

# TPS4812-Q1 100V Low $I_Q$ Automotive High-Side Switch Controller With Bi-directional IMON, Low Power Mode, Load Wakeup, $I^2t$ , and Diagnostics

## 1 Features

- AEC-Q100 automotive qualified for grade 1 temperature
- 3.5V to 95V input range (100V absolute maximum)
- Reverse input and output protection down to  $-65V$
- Integrated 12V charge pump
- Low  $I_Q = 20\mu A$  in low power mode ( $\overline{LPM} = Low$ )
- Low  $1\mu A$  shutdown current ( $EN/UVLO = Low$ )
- Dual gate drive: GATE: 0.5A src/2A sink G: 100 $\mu A$  src/0.39A sink
- Accurate  $I^2t$  overcurrent protection (IOC) with adjustable circuit breaker timer ( $I^2t$ )
- Accurate and fast (5 $\mu s$ ) short-circuit protection
- Fast transition (5 $\mu s$ ) from low power mode to active mode using adjustable load wakeup threshold or  $\overline{LPM}$  trigger with WAKE indication
- Accurate analog bi-directional current monitor output (IMON,  $I_{DIR}$ ):  $\pm 2\%$  at 30mV  $V_{SNS}$
- NTC based overtemperature sensing (TMP) and monitoring output (ITMPO)
- Fault indication ( $\overline{FLT}$ ) during short circuit fault,  $I^2t$ , charge pump UVLO, overtemperature
- TPS48120-Q1 ( $I^2t$  enabled), TPS48121-Q1 ( $I^2t$  disabled)
- Accurate ( $\pm 2\%$ ) and adjustable undervoltage lockout (UVLO)

## 2 Applications

- [Power distribution box](#)
- [Body control module](#)
- [DC/DC converter](#)
- [Battery management system](#)

## 3 Description

TPS4812-Q1 is a family of low  $I_Q$  smart high side drivers with protection and diagnostics. With wide operating voltage range of 3.5V to 95V, 100V absmax the device is suitable for 12V, 24V and 48V automotive system designs.

It has two integrated gate drives with 0.5A source and 2A sink (GATE) and 100 $\mu A$  source and 0.39A sink (G). With  $\overline{LPM}$  Low, the low power path is kept ON and the main FETs are turned OFF with  $I_Q$  of 20 $\mu A$  (typ). Auto Load wakeup threshold adjusted using  $R_{BYPASS}$  resistor placed across DRN and CS2-.  $I_Q$  reduces to 1 $\mu A$  (typ) with  $EN/UVLO$  low.

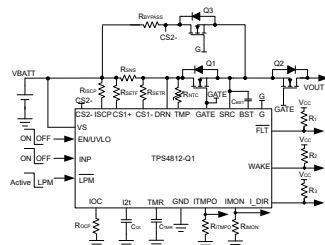
The device has accurate bi-directional current sensing ( $\pm 2\%$ ) output (IMON,  $I_{DIR}$ ) with adjustable  $I^2t$  based overcurrent and short circuit protection using an external  $R_{SNS}$  resistor and  $\overline{FLT}$  indication. Auto-retry and latch-off fault behavior can be configured. The device also has NTC based temperature sensing (TMP) and monitoring output (ITMPO) output for overtemperature detection of external FETs.

The TPS4812-Q1 is available in 23-pin VQFN package.

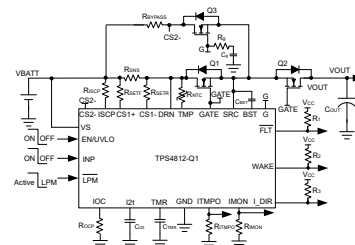
### Package Information

| PART NUMBER                 | PACKAGE <sup>(1)</sup> | PACKAGE SIZE <sup>(2)</sup> |
|-----------------------------|------------------------|-----------------------------|
| TPS48120-Q1,<br>TPS48121-Q1 | RGE (VQFN, 23)         | 4.00mm $\times$ 4.00mm      |

- (1) For all available packages, see the orderable addendum at the end of the data sheet.
- (2) The package size (length  $\times$  width) is a nominal value and includes pins, where applicable.



**TPS48120-Q1 Application Circuit Driving PAAT Loads With Load Wakeup**



**TPS48120-Q1 Application Circuit Driving PAAT Loads With Load Wakeup and Bulk Capacitor Charging**

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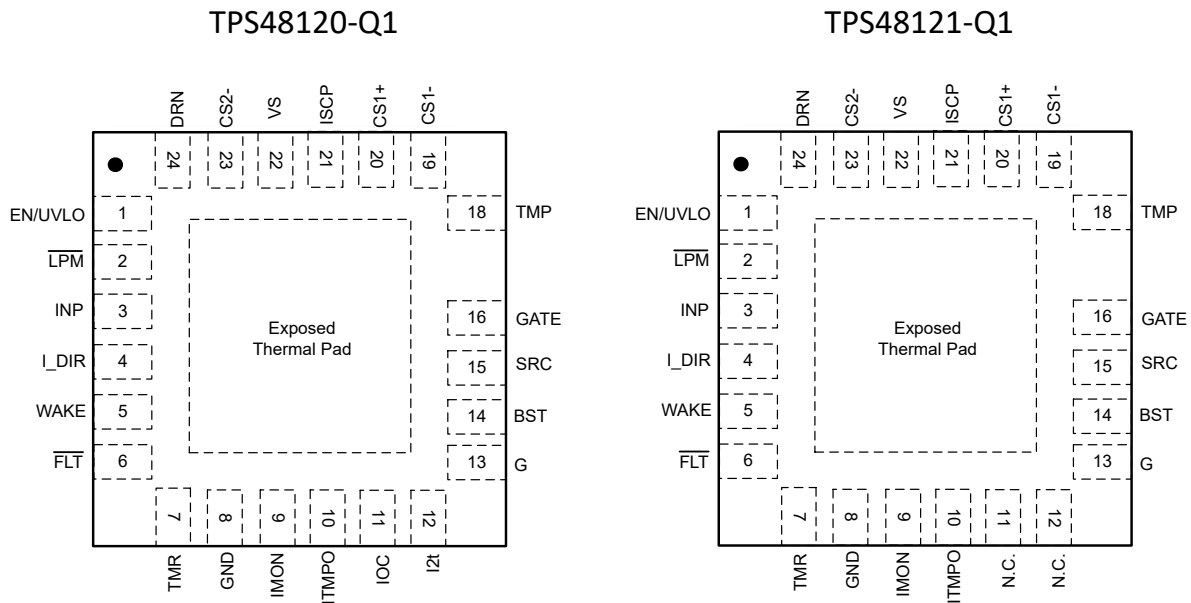
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## 4 Device Comparison

**Table 4-1. Device Comparison**

| Device name /Feature        | TPS48120-Q1 | TPS48121-Q1 |
|-----------------------------|-------------|-------------|
| I <sup>2</sup> T Protection | Yes         | No          |

## 5 Pin Configuration and Functions



**Figure 5-1. RGE Package, 23-Pin VQFN (Transparent Top View)**

**Table 5-1. Pin Functions**

| PIN                     |             |             | TYPE <sup>(1)</sup> | DESCRIPTION                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                         |
|-------------------------|-------------|-------------|---------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME                    | TPS48120-Q1 | TPS48121-Q1 |                     |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| EN/UVLO                 | 1           | 1           | I                   | EN/UVLO input.<br>A voltage on this pin above $V_{(UVLO)}$ 1.21V enables normal operation. If EN/UVLO is below $V_{(UVLO)}$ then Gate drives are turned OFF.<br>Forcing this pin below $V_{(ENF)}$ 0.3V shuts down the device reducing quiescent current to approximately 1 $\mu$ A (typ). Optionally connect to the input supply through a resistive divider to set the undervoltage lockout.<br>When EN/UVLO is left floating an internal pull down of 100nA pulls EN/UVLO low and keeps the device in OFF state. |
| $\overline{\text{LPM}}$ | 2           | 2           | I                   | Mode control input.<br>When driven high, the device enters into active mode. When driven low, the devices enter into low power mode.<br>If low power mode is not required, $\overline{\text{LPM}}$ pin can be tied to EN/UVLO pin.<br>When $\overline{\text{LPM}}$ is left floating an internal pull down of 100nA pulls $\overline{\text{LPM}}$ low.                                                                                                                                                               |
| INP                     | 3           | 3           | I                   | Input signal for external FET control.<br>CMOS compatible input reference to GND that sets the state of GATE pin.<br>INP has an internal weak pull down of 100nA to GND to keep GATE pulled to SRC when INP is left floating.                                                                                                                                                                                                                                                                                       |
| I_DIR                   | 4           | 4           | I                   | Open drain I_DIR output.<br>This pin is asserted low by device when current through CS1+ and CS1– flows in reverse direction.                                                                                                                                                                                                                                                                                                                                                                                       |

**Table 5-1. Pin Functions (continued)**

| PIN   |             |             | TYPE <sup>(1)</sup> | DESCRIPTION                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                       |
|-------|-------------|-------------|---------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME  | TPS48120-Q1 | TPS48121-Q1 |                     |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   |
| WAKE  | 5           | 5           | O                   | Open drain WAKE output.<br>This pin is asserted low by device when device enters into active mode (when $\overline{\text{LPM}}$ is driven high or when a load wakeup event has occurred).                                                                                                                                                                                                                                                                                                                                                                                         |
| FLT   | 6           | 6           | O                   | Open drain fault output.<br>$\overline{\text{FLT}}$ goes low during charge pump UVLO, Main FET SCP, I <sup>2</sup> t timer trigger, NTC based external FET overtemperature fault.<br>This pin asserts low after the voltage on the I2t pin has reached the fault threshold of 2V. This pin indicates the main FET is about to turn off due to an overload condition. This pin asserts low along with GATE turn off during short-circuit.<br>The $\overline{\text{FLT}}$ pin does not go to a high impedance state until the overcurrent condition and the auto-retry time expire. |
| TMR   | 7           | 7           | I                   | Auto-retry or latch timer input after overcurrent fault.<br>A capacitor across TMR pin to GND sets the times for retry periods. Leave open for fastest setting.<br>Connect resistor across C <sub>TMR</sub> from TMR pin to GND for latch-off functionality.                                                                                                                                                                                                                                                                                                                      |
| GND   | 8           | 8           | G                   | Connect GND to system ground.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| IMON  | 9           | 9           | O                   | Analog bi-directional current monitor output.<br>This pin sources a scaled down ratio of current through the external current sense resistor R <sub>SNS</sub> . A resistor from this pin to GND converts current proportional to voltage.<br>If unused, leave floating or can be connected to ground.                                                                                                                                                                                                                                                                             |
| ITMPO | 10          | 10          | O                   | Analog temperature output.<br>Analog voltage feedback provides a voltage proportional to thermistor temperature.<br>If unused, leave floating.                                                                                                                                                                                                                                                                                                                                                                                                                                    |
| IOC   | 11          | —           | I                   | Overcurrent detection setting.<br>A resistor across IOC to GND sets the over current comparator threshold. IOC pin can also be driven externally using MCU.                                                                                                                                                                                                                                                                                                                                                                                                                       |
| N.C.  | —           | 11          | —                   | No connect.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                       |
| I2t   | 12          | —           | O                   | I2t timer input.<br>A capacitor across I2t pin to GND sets the times for overcurrent (t <sub>OC</sub> ).                                                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| N.C.  | —           | 12          | —                   | No connect.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                       |
| G     | 13          | 13          | O                   | Gate of external bypass FET.<br>100μA peak source and 0.39A sink capacity.<br>Connect to the gate of the external bypass FET.                                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| BST   | 14          | 14          | O                   | High side bootstrapped supply.<br>An external capacitor with a minimum value of 0.1μF should be connected between this pin and SRC. Voltage swing on this pin is 12V to (VIN + 12V).                                                                                                                                                                                                                                                                                                                                                                                              |
| SRC   | 15          | 15          | O                   | Source connection of the external FET.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                            |
| GATE  | 16          | 16          | O                   | High current gate driver pull-up and pull-down.<br>0.5A peak source and 2A sink capacity.<br>This pin pulls GATE up to BST and down to SRC. For the fastest turn-on and turn-off, tie this pin directly to the gate of the external high side MOSFET in main path.                                                                                                                                                                                                                                                                                                                |

**Table 5-1. Pin Functions (continued)**

| PIN  |             |             | TYPE <sup>(1)</sup> | DESCRIPTION                                                                                                                                                                                                                                       |
|------|-------------|-------------|---------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME | TPS48120-Q1 | TPS48121-Q1 |                     |                                                                                                                                                                                                                                                   |
| TMP  | 18          | 18          | I                   | Temperature input.<br>Analog connection to external NTC thermistor<br>Connect TMP pin directly to VS if this feature is not used                                                                                                                  |
| CS1– | 19          | 19          | I                   | Main path current sense negative input.<br>Connect a resistor ( $R_{SETF}$ ) across CS1– to the external current sense resistor to set IMON gain in reverse direction.                                                                            |
| CS1+ | 20          | 20          | I                   | Main path current sense positive input.<br>Connect a resistor ( $R_{SETF}$ ) across CS1+ to the external current sense resistor to set IMON gain in forward direction.<br>Connect CS1+ and CS1– to VBATT if main FET current sensing is not used. |
| ISCP | 21          | 21          | I                   | Short-circuit detection threshold setting.<br>Connect ISCP to DRN if short-circuit protection is not desired.                                                                                                                                     |
| VS   | 22          | 22          | P                   | Supply pin of the controller.                                                                                                                                                                                                                     |
| CS2– | 23          | 23          | I                   | Bypass path current sense negative input.                                                                                                                                                                                                         |
| DRN  | 24          | 24          | I                   | Main path SCP sense negative input.<br>Connect DRN+ and CS2– together to VBATT after RSNS if bypass path is not used.                                                                                                                             |
| GND  | Thermal Pad | —           | —                   | Connect exposed thermal pad to GND plane.                                                                                                                                                                                                         |

(1) I = Input, O = Output, I/O = Input or Output, G = Ground, P = Power.

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                                       |                                                                            | MIN        | MAX                | UNIT |
|---------------------------------------|----------------------------------------------------------------------------|------------|--------------------|------|
| Input pins                            | VS, CS1+, CS1–, DRN, CS2–, ISCP, TMP to GND                                | –65        | 100                | V    |
| Input pins                            | VS, CS1+, CS1–, DRN, CS2–, ISCP, TMP to SRC                                | –65        | 100                | V    |
| Input pins                            | SRC to GND                                                                 | –65        | 100                | V    |
| Input pins                            | GATE, G, BST to SRC                                                        | –0.3       | 19                 | V    |
| Input pins                            | TMR to GND                                                                 | –0.3       | 5.5                | V    |
| Input pins                            | IOC to GND, TPS48120-Q1 only                                               | –1         | 5.5                | V    |
| Input pins                            | EN/UVLO, INP, LPM; $V_{(VS)} > 0$ V                                        | –1         | 100                | V    |
| Input pins                            | EN/UVLO, INP, LPM; $V_{(VS)} \leq 0$ V                                     | $V_{(VS)}$ | $(100 + V_{(VS)})$ | V    |
| Input pins                            | CS1+ to CS1–                                                               | –0.3       | 0.4                | V    |
| Input pins                            | DRN to CS2–                                                                | –5         | 100                | V    |
| Output pins                           | FLT, I_DIR, WAKE to GND                                                    | –1         | 20                 | V    |
| Output pins                           | IMON to GND                                                                | –1         | 5.5                | V    |
| Output pins                           | I2t, ITMPO to GND, TPS48120-Q1 only                                        | –1         | 7.5                | V    |
| Output pins                           | ITMPO to GND, TPS48121-Q1 only                                             | –1         | 7.5                | V    |
| Output pins                           | GATE, G, BST to GND                                                        | –65        | 112                | V    |
| Sink current                          | $I_{(FLT)}$ , $I_{(I\_DIR)}$ , $I_{(WAKE)}$                                |            | 10                 | mA   |
| Sink current                          | $I_{(CS1+)}$ to $I_{(CS1-)}$ , 1msec ; $I_{(DRN)}$ to $I_{(CS2-)}$ , 1msec |            | 100                | mA   |
| Operating junction temperature, $T_J$ | <sup>(2)</sup>                                                             | –40        | 150                | °C   |
| Storage temperature, $T_{stg}$        |                                                                            | –40        | 150                |      |

- (1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) High junction temperatures degrade operating lifetimes. Operating lifetime is de-rated for junction temperatures greater than 125°C.

### 6.2 ESD Ratings

|             |                         |                                                         | VALUE | UNIT |
|-------------|-------------------------|---------------------------------------------------------|-------|------|
| $V_{(ESD)}$ | Electrostatic discharge | Human body model (HBM), per AEC Q100-002 <sup>(1)</sup> | ±2000 | V    |
|             |                         | Charged device model (CDM), per AEC Q100-011            | ±750  |      |
|             |                         | Other pins                                              | ±500  |      |

- (1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                    |                                             | MIN | NOM | MAX | UNIT |
|--------------------|---------------------------------------------|-----|-----|-----|------|
| Input pins         | VS, CS1+, CS1–, DRN, CS2–, ISCP, TMP to GND | –60 |     | 95  | V    |
| Input pins         | EN/UVLO, INP, LPM                           | 0   |     | 95  | V    |
| Input pins         | IOC, TMR to GND, , TPS48120-Q1 only         | 0   |     | 5   | V    |
| Input pins         | TMR to GND, TPS48121-Q1 only                | 0   |     | 5   | V    |
| Output pins        | I2t, IMON, ITMPO to GND, TPS48120-Q1 only   | 0   |     | 5   | V    |
| Output pins        | IMON, ITMPO to GND, TPS48121-Q1 only        | 0   |     | 5   | V    |
| Output pins        | FLT, WAKE, I_DIR to GND                     | 0   |     | 15  | V    |
| External capacitor | VS, SRC to GND                              | 22  |     |     | nF   |

### 6.3 Recommended Operating Conditions (continued)

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                    |                                               | MIN | NOM | MAX | UNIT |
|--------------------|-----------------------------------------------|-----|-----|-----|------|
| External capacitor | BST to SRC                                    | 0.1 |     |     | μF   |
| External capacitor | I2t to GND                                    | 10  |     |     | nF   |
| External capacitor | TMR to GND                                    | 1   |     |     | nF   |
| T <sub>j</sub>     | Operating junction temperature <sup>(2)</sup> | –40 |     | 150 | °C   |

(1) Recommended Operating Conditions are conditions under which the device is intended to be functional. For specifications and test conditions, see Electrical Characteristics.

(2) High junction temperatures degrade operating lifetimes. Operating lifetime is de-rated for junction temperatures greater than 125°C.

### 6.4 Thermal Information

| THERMAL METRIC <sup>(1)</sup> |                                              | TPS4812x-Q1 | UNIT |
|-------------------------------|----------------------------------------------|-------------|------|
|                               |                                              | RGE (VQFN)  |      |
|                               |                                              | 23 PINS     |      |
| R <sub>θJA</sub>              | Junction-to-ambient thermal resistance       | 43          | °C/W |
| R <sub>θJC(top)</sub>         | Junction-to-case (top) thermal resistance    | 38.3        | °C/W |
| R <sub>θJB</sub>              | Junction-to-board thermal resistance         | 20.8        | °C/W |
| Ψ <sub>JT</sub>               | Junction-to-top characterization parameter   | 0.8         | °C/W |
| Ψ <sub>JB</sub>               | Junction-to-board characterization parameter | 20.7        | °C/W |

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

### 6.5 Electrical Characteristics

T<sub>J</sub> = –40 °C to +125°C. V<sub>(VS)</sub> = 48 V, V<sub>(BST – SRC)</sub> = 12 V, V<sub>(SRC)</sub> = 0 V

| PARAMETER                                                                            |                                                                   | TEST CONDITIONS                                                                   | MIN  | TYP  | MAX   | UNIT |
|--------------------------------------------------------------------------------------|-------------------------------------------------------------------|-----------------------------------------------------------------------------------|------|------|-------|------|
| <b>SUPPLY VOLTAGE (VS)</b>                                                           |                                                                   |                                                                                   |      |      |       |      |
| VS                                                                                   | Operating input voltage                                           |                                                                                   | 3.5  |      | 95    | V    |
| V <sub>(S_PORR)</sub>                                                                | Input supply POR threshold, rising                                |                                                                                   | 2.06 | 2.6  | 3.12  | V    |
| V <sub>(S_PORF)</sub>                                                                | Input supply POR threshold, falling                               |                                                                                   | 2    | 2.5  | 3.01  | V    |
|                                                                                      | Total System Quiescent current, I <sub>(GND)</sub>                | V <sub>(EN/UVLO)</sub> = V <sub>(LPM)</sub> = 2 V                                 |      | 430  | 525   | μA   |
|                                                                                      | Total System Quiescent current, I <sub>(GND)</sub>                | V <sub>(EN/UVLO)</sub> = V <sub>(LPM)</sub> = 2 V<br>TPS48121-Q1 Only             |      | 370  | 470   | μA   |
|                                                                                      | Total System Quiescent current, I <sub>(GND)</sub>                | V <sub>(EN/UVLO)</sub> = 2V, V <sub>(LPM)</sub> = 0 V                             |      | 20   | 24    | μA   |
| I <sub>(SHDN)</sub>                                                                  | SHDN current, I <sub>(GND)</sub>                                  | V <sub>(SRC)</sub> = 48 V, V <sub>(EN/UVLO)</sub> = 0 V, V <sub>(SRC)</sub> = 0 V |      | 0.9  | 3.4   | μA   |
| I <sub>(REV_VS)</sub>                                                                | I <sub>(VS)</sub> leakage current during Reverse Polarity         | 0 V ≤ V <sub>(VS)</sub> ≤ – 65 V                                                  |      |      | 60    | μA   |
| I <sub>(REV_SRC)</sub>                                                               | I <sub>(SRC)</sub> leakage current during Reverse Polarity        | 0 V ≤ V <sub>(VS)</sub> ≤ – 65 V                                                  |      |      | 27    | μA   |
| <b>ENABLE, UNDERVOLTAGE LOCKOUT (EN/UVLO) AND OVER VOLTAGE PROTECTION INPUT (OV)</b> |                                                                   |                                                                                   |      |      |       |      |
| V <sub>(UVLOR)</sub>                                                                 | UVLO threshold voltage, rising                                    |                                                                                   | 1.16 | 1.2  | 1.245 | V    |
| V <sub>(UVLOF)</sub>                                                                 | UVLO threshold voltage, falling                                   |                                                                                   | 1.09 | 1.11 | 1.16  | V    |
| V <sub>(ENR)</sub>                                                                   | Enable threshold voltage for low I <sub>q</sub> shutdown, rising  |                                                                                   |      |      | 1     | V    |
| V <sub>(ENF)</sub>                                                                   | Enable threshold voltage for low I <sub>q</sub> shutdown, falling |                                                                                   | 0.3  |      |       | V    |
| I <sub>(EN/UVLO)</sub>                                                               | Enable input leakage current                                      | V <sub>(EN/UVLO)</sub> = 48 V                                                     |      |      | 500   | nA   |

## 6.5 Electrical Characteristics (continued)

$T_J = -40^\circ\text{C}$  to  $+125^\circ\text{C}$ .  $V_{(VS)} = 48\text{ V}$ ,  $V_{(BST - SRC)} = 12\text{ V}$ ,  $V_{(SRC)} = 0\text{ V}$

| PARAMETER                                                                   |                                                                                                     | TEST CONDITIONS                                                                                  | MIN   | TYP  | MAX  | UNIT          |
|-----------------------------------------------------------------------------|-----------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------|-------|------|------|---------------|
| <b>CHARGE PUMP (BST–SRC)</b>                                                |                                                                                                     |                                                                                                  |       |      |      |               |
| $I_{(BST\_LPM)}$                                                            | Charge Pump Supply current in LPM                                                                   | $V_{(BST - SRC)} = 10\text{ V}$ , $V_{(EN/UVLO)} = 2\text{ V}$ , $V_{(LPM)} = 0\text{ V}$        | 175   | 360  | 575  | $\mu\text{A}$ |
| $I_{(BST\_AM)}$                                                             | Charge Pump Supply current in active mode                                                           | $V_{(BST - SRC)} = 12\text{ V}$ , $V_{(EN/UVLO)} = 2\text{ V}$ , $V_{(LPM)} = 2\text{ V}$        | 300   | 540  | 775  | $\mu\text{A}$ |
| $V_{(BST\_UVLO)}$                                                           | $V_{(BST - SRC)}$ UVLO voltage threshold, rising                                                    | $V_{(EN/UVLO)} = 2\text{ V}$                                                                     | 7     | 7.6  | 8.4  | V             |
|                                                                             | $V_{(BST - SRC)}$ UVLO voltage threshold, falling                                                   | $V_{(EN/UVLO)} = 2\text{ V}$                                                                     | 6     | 6.6  | 7.2  | V             |
| $V_{CP(AM\_LOW)}$                                                           | Charge Pump Turn ON voltage in active mode                                                          | $V_{(EN/UVLO)} = 2\text{ V}$ , $V_{(LPM)} = 2\text{ V}$                                          | 9.5   | 10.4 | 12.3 | V             |
| $V_{CP(AM\_HIGH)}$                                                          | Charge Pump Turnoff voltage in active mode                                                          | $V_{(EN/UVLO)} = 2\text{ V}$ , $V_{(LPM)} = 2\text{ V}$                                          | 10.42 | 11.3 | 13   | V             |
| $V_{CP(LPM\_LOW)}$                                                          | Charge Pump Turn ON voltage in low power mode                                                       | $V_{(EN/UVLO)} = 2\text{ V}$ , $V_{(LPM)} = 0\text{ V}$                                          | 8.3   | 9.3  | 10.6 | V             |
| $V_{CP(LPM\_HIGH)}$                                                         | Charge Pump Turnoff voltage in low power mode                                                       | $V_{(EN/UVLO)} = 2\text{ V}$ , $V_{(LPM)} = 0\text{ V}$                                          | 9.02  | 10.3 | 11.8 | V             |
| $V_{CP(VS\_3V)}$                                                            | Charge Pump Voltage at $V_{(VS)} = 3\text{ V}$                                                      | $V_{(EN/UVLO)} = 2\text{ V}$                                                                     | 8     |      |      | V             |
| $V_{(G\_GOOD)}$                                                             | G Drive Good rising threshold w.r.t BST when bypass comparator reference changes from 2 V to 200 mV |                                                                                                  |       | 2.3  |      | V             |
| $I_{(SRC)}$                                                                 | SRC pin leakage current                                                                             | $V_{(EN/UVLO)} = 2\text{ V}$ , $V_{(INP)} = 0$ , $V_{(LPM)} = 2\text{ V}$                        |       | 1    | 1.57 | $\mu\text{A}$ |
| <b>GATE DRIVER OUTPUTS (GATE, G)</b>                                        |                                                                                                     |                                                                                                  |       |      |      |               |
| $I_{(GATE)}$                                                                | Peak Source Current                                                                                 |                                                                                                  |       | 0.5  |      | A             |
| $I_{(GATE)}$                                                                | Peak Sink Current                                                                                   |                                                                                                  |       | 2    |      | A             |
| $I_{(G)}$                                                                   | Gate charge (sourcing) current, on state                                                            |                                                                                                  |       | 100  |      | $\mu\text{A}$ |
| $I_{(G)}$                                                                   | G Peak Sink Current                                                                                 |                                                                                                  |       | 390  |      | mA            |
| <b>CURRENT SENSE AND CURRENT MONITOR (CS1+, CS1–, IMON, I_DIR)</b>          |                                                                                                     |                                                                                                  |       |      |      |               |
| $V_{(OS\_SET)}$                                                             | Input referred offset ( $V_{SNS}$ to $V_{(IMON)}$ scaling)                                          |                                                                                                  | –140  |      | 140  | $\mu\text{V}$ |
| $V_{(GE\_SET)}$                                                             | Gain error ( $V_{SNS}$ to $V_{(IMON)}$ scaling)                                                     |                                                                                                  | –1    |      | 1    | %             |
| $V_{(IMON\_Acc)}$                                                           | IMON accuracy                                                                                       | $V_{SNS} = \pm 6\text{ mV}$                                                                      | –5    |      | 5    | %             |
| $V_{(IMON\_Acc)}$                                                           | IMON accuracy                                                                                       | $V_{SNS} = \pm 10\text{ mV}$                                                                     | –5    |      | 5    | %             |
| $V_{(IMON\_Acc)}$                                                           | IMON accuracy                                                                                       | $V_{SNS} = \pm 15\text{ mV}$                                                                     | –2    |      | 2    | %             |
| $V_{(IMON\_Acc)}$                                                           | IMON accuracy                                                                                       | $V_{SNS} = \pm 30\text{ mV}$                                                                     | –2    |      | 2    | %             |
| <b>OVERCURRENT (I2t) AND SHORT CIRCUIT PROTECTION (IOC, I2t, ISCP, DRN)</b> |                                                                                                     |                                                                                                  |       |      |      |               |
| $V_{(OCP)}$                                                                 | OCP threshold accuracy                                                                              | $15\text{ mV} \geq V_{(OCP)} \geq 100\text{ mV}$                                                 | –7.5  |      | 7.5  | %             |
| $I^2_{(I2t\_Acc)}$                                                          | $I^2$ current accuracy on I2t pin                                                                   | $15\text{ mV} \geq V_{(OCP)} \geq 100\text{ mV}$<br>$V_{SNS} = V_{(OCP)} + 50\%$ of $V_{(OCP)}$  | –15   |      | 15   | %             |
| $I^2_{(I2t\_Acc)}$                                                          | $I^2$ current accuracy on I2t pin                                                                   | $15\text{ mV} \geq V_{(OCP)} \geq 100\text{ mV}$<br>$V_{SNS} = V_{(OCP)} + 100\%$ of $V_{(OCP)}$ | –10   |      | 10   | %             |
| $I^2_{(I2t\_Acc)}$                                                          | $I^2$ current accuracy on I2t pin                                                                   | $15\text{ mV} \geq V_{(OCP)} \geq 100\text{ mV}$<br>$V_{SNS} = V_{(OCP)} + 200\%$ of $V_{(OCP)}$ | –10   |      | 10   | %             |
| $V_{(I2t\_OC)}$                                                             | I2t pin voltage threshold for overcurrent shutdown                                                  |                                                                                                  | 1.93  | 2    | 2.09 | V             |
| $I_{(I2t\_Charge)}$                                                         | Charging current on I2t pin to $V_{(I2t\_OFFSET)}$                                                  |                                                                                                  |       | 5100 |      | $\mu\text{A}$ |
| $R_{(I2t\_Discharge)}$                                                      | Internal switch discharge resistance                                                                |                                                                                                  |       | 1200 |      | $\Omega$      |

## 6.5 Electrical Characteristics (continued)

$T_J = -40^\circ\text{C}$  to  $+125^\circ\text{C}$ .  $V_{(VS)} = 48\text{ V}$ ,  $V_{(BST - SRC)} = 12\text{ V}$ ,  $V_{(SRC)} = 0\text{ V}$

| PARAMETER                                                       |                                                                                                                    | TEST CONDITIONS                                                                                                                                      | MIN  | TYP  | MAX  | UNIT          |
|-----------------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|------|---------------|
| $V_{(I2t\_OFFSET)}$                                             | I2t pin offset voltage                                                                                             |                                                                                                                                                      | 490  | 500  | 415  | mV            |
| $V_{(REF\_OC)}$                                                 | IOC pin reference voltage                                                                                          |                                                                                                                                                      | 190  | 200  | 205  | mV            |
| $V_{(SCP)}$                                                     | SCP threshold accuracy                                                                                             | $V_{(SNS\_SCP)} = 20\text{ mV}$ ,<br>$R_{(ISCP)} = 732\ \Omega$                                                                                      | 19   | 20   | 21   | mV            |
| $V_{(SCP)}$                                                     | SCP threshold accuracy                                                                                             | $V_{(SNS\_SCP)} = 100\text{ mV}$ ,<br>$R_{(ISCP)} = 3.92\text{ k}\Omega$                                                                             | 95   | 100  | 105  | mV            |
| $I_{SCP}$                                                       | SCP Input Bias current                                                                                             |                                                                                                                                                      | 24.4 | 25   | 25.2 | $\mu\text{A}$ |
| <b>LOAD WAKEUP COMPARATOR (CS2-, DRN)</b>                       |                                                                                                                    |                                                                                                                                                      |      |      |      |               |
| $V_{(LPM\_SCP)}$                                                | Short-circuit threshold in LPM                                                                                     |                                                                                                                                                      | 1.72 | 2    | 2.17 | V             |
| $V_{(LWU)}$                                                     | Load wakeup current threshold                                                                                      |                                                                                                                                                      | 177  | 200  | 218  | mV            |
| <b>AUTO-RETRY OR LATCH-OFF TIMER (TMR)</b>                      |                                                                                                                    |                                                                                                                                                      |      |      |      |               |
| $I_{(TMR\_SRC\_FLT)}$                                           | TMR source current                                                                                                 |                                                                                                                                                      | 2    | 2.5  | 3    | $\mu\text{A}$ |
| $I_{(TMR\_SNK)}$                                                | TMR sink current                                                                                                   |                                                                                                                                                      | 2    | 2.5  | 3    | $\mu\text{A}$ |
| $V_{(TMR\_HIGH)}$                                               | Voltage at TMR pin for AR counter rising threshold                                                                 |                                                                                                                                                      | 1.04 | 1.23 | 1.42 | V             |
| $V_{(TMR\_LOW)}$                                                | Voltage at TMR pin for AR counter falling threshold                                                                |                                                                                                                                                      | 0.15 | 0.25 | 0.39 | V             |
| $N_{(A-R\text{ Count})}$                                        |                                                                                                                    |                                                                                                                                                      |      | 32   |      |               |
| <b>TEMPERATURE MONITOR (CS1-, TMP, ITMPO)</b>                   |                                                                                                                    |                                                                                                                                                      |      |      |      |               |
| $V_{(REF\_TMP)}$                                                | Temperature amplifier internal reference voltage                                                                   |                                                                                                                                                      | 475  | 500  | 525  | mV            |
| $V_{(ITMPO)}$                                                   | Temperature monitor output voltage at $150^\circ\text{C}$<br>$R_{(NTC)} = 10\text{ k}\Omega$ at $25^\circ\text{C}$ | $R_{(TMP)} = 330\ \Omega$ ,<br>$R_{(NTC)} = 309\ \Omega$ at $150^\circ\text{C}$ ,<br>$R_{(ITMPO)} = 2.55\text{ k}\Omega$                             | -6   |      | 6.64 | %             |
| $V_{(ITMPO)}$                                                   | Temperature monitor output voltage at $150^\circ\text{C}$<br>$R_{(NTC)} = 47\text{ k}\Omega$ at $25^\circ\text{C}$ | $R_{(TMP)} = 1\text{ k}\Omega$ ,<br>$R_{(NTC)} = 520\ \Omega$ at $150^\circ\text{C}$ ,<br>$R_{(ITMPO)} = 6.19\text{ k}\Omega$                        | -6   |      | 6.67 | %             |
| $I_{(TMP)}$                                                     | TMP leakage current                                                                                                |                                                                                                                                                      |      |      | 100  | nA            |
| $V_{(TMP\_OT)}$                                                 | Over temperature threshold                                                                                         |                                                                                                                                                      | 1.9  | 2    | 2.06 | V             |
| <b>INPUT CONTROLS (INP, INP_G, LPM), &amp; FAULT FLAG (FLT)</b> |                                                                                                                    |                                                                                                                                                      |      |      |      |               |
| $R_{(FLT)}$ , $R_{(WAKE)}$ , $R_{(I\_DIR)}$                     | $\overline{\text{FLT}}$ , WAKE, I_DIR Pull-down resistance                                                         |                                                                                                                                                      |      | 70   |      | $\Omega$      |
| $I_{(FLT)}$ , $I_{(WAKE)}$ , $I_{(I\_DIR)}$                     | $\overline{\text{FLT}}$ , WAKE, I_DIR leakage current                                                              | $0\text{ V} \leq V_{(FLT)} \leq 20\text{ V}$ ,<br>$0\text{ V} \leq V_{(WAKE)} \leq 20\text{ V}$ ,<br>$0\text{ V} \leq V_{(I\_DIR)} \leq 20\text{ V}$ |      |      | 400  | nA            |
| $V_{(INP\_H)}$ , $V_{(LPM\_H)}$                                 |                                                                                                                    |                                                                                                                                                      |      |      | 2    | V             |
| $V_{(INP\_L)}$ , $V_{(LPM\_L)}$                                 |                                                                                                                    |                                                                                                                                                      | 0.72 |      |      | V             |
| $V_{(INP\_Hys)}$ , $V_{(LPM\_Hys)}$                             | INP, LPM Hysteresis                                                                                                |                                                                                                                                                      |      | 400  |      | mV            |
| $I_{(INP)}$ , $I_{(LPM)}$                                       | INP, LPM leakage current                                                                                           |                                                                                                                                                      |      |      | 200  | nA            |

## 6.6 Switching Characteristics

$T_J = -40^\circ\text{C}$  to  $+125^\circ\text{C}$ .  $V_{(VS)} = 48\text{ V}$ ,  $V_{(BST - SRC)} = 12\text{ V}$ ,  $V_{(SRC)} = 0\text{ V}$

| PARAMETER                        | TEST CONDITIONS                                                                                                       | MIN | TYP  | MAX | UNIT          |
|----------------------------------|-----------------------------------------------------------------------------------------------------------------------|-----|------|-----|---------------|
| $t_{\text{GATE}(\text{INP\_H})}$ | INP Turn ON propagation Delay<br>INP $\uparrow$ to GATE $\uparrow$ , $C_{\text{L}(\text{GATE})} = 47\text{ nF}$       |     | 1.2  | 2.5 | $\mu\text{s}$ |
| $t_{\text{GATE}(\text{INP\_L})}$ | INP Turn OFF propagation Delay<br>INP $\downarrow$ to GATE $\downarrow$ , $C_{\text{L}(\text{GATE})} = 47\text{ nF}$  |     | 0.35 | 1.5 | $\mu\text{s}$ |
| $t_{\text{G\_ON}(\text{LPM})}$   | Active mode to LPM mode transition delay<br>LPM $\downarrow$ to G $\uparrow$ , $C_{\text{L}(\text{G})} = 1\text{ nF}$ |     | 1.8  | 9   | $\mu\text{s}$ |

## 6.6 Switching Characteristics (continued)

$T_J = -40\text{ }^{\circ}\text{C}$  to  $+125\text{ }^{\circ}\text{C}$ .  $V_{(VS)} = 48\text{ V}$ ,  $V_{(BST - SRC)} = 12\text{ V}$ ,  $V_{(SRC)} = 0\text{ V}$

| PARAMETER                                   |                                                                                      | TEST CONDITIONS                                                                                                                                                             | MIN | TYP | MAX | UNIT          |
|---------------------------------------------|--------------------------------------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|-----|-----|---------------|
| $t_{\text{GATE\_OFF(LPM)}}$                 | Active mode to LPM mode transition delay                                             | LPM $\downarrow$ , G $\uparrow$ (above $V_{(G\_GOOD)}$ ) to GATE $\downarrow$ , WAKE $\uparrow$ (low to High Z), $C_{L(GATE)} = 47\text{ nF}$                               |     | 37  | 51  | $\mu\text{s}$ |
| $t_{\text{GATE(WAKE\_LPM)}}$                | LPM Mode to Active mode transition delay with LPM trigger                            | LPM $\uparrow$ to GATE $\uparrow$ , $C_{L(GATE)} = 47\text{ nF}$                                                                                                            |     | 3.8 | 6   | $\mu\text{s}$ |
| $t_{\text{G(WAKE\_LPM)}}$                   | LPM Mode to Active mode transition delay with LPM trigger                            | LPM $\uparrow$ , GATE $\uparrow$ (above $V_{(G\_GOOD)}$ ) to G $\downarrow$ , WAKE $\downarrow$ , $C_{L(G)} = 47\text{ nF}$ , $V_{(LPM)} = 0\text{ V}$                      |     | 9   | 15  | $\mu\text{s}$ |
| $t_{\text{GATE(WAKE\_LWU)}}$                | GATE turn ON propagation delay during Load wakeup                                    | $V_{(DRN-CS2-)} \uparrow V_{(LWU)}$ to GATE $\uparrow$ , $C_{L(GATE)} = 47\text{ nF}$ , $V_{(LPM)} = 0\text{ V}$                                                            |     | 4   | 5.5 | $\mu\text{s}$ |
| $t_{\text{G(WAKE\_LWU)}}$                   | G turn OFF propagation delay during Load wakeup                                      | $V_{(DRN-CS2-)} \uparrow V_{(LWU)}$ , GATE $\uparrow$ (above $V_{(G\_GOOD)}$ ) to G $\downarrow$ , WAKE $\downarrow$ , $C_{L(G)} = 47\text{ nF}$ , $V_{(LPM)} = 0\text{ V}$ |     | 9   | 15  | $\mu\text{s}$ |
| $t_{\text{GATE(EN\_OFF)}}$                  | EN Turn OFF Propagation Delay                                                        | EN $\downarrow$ to GATE $\downarrow$ , $C_{L(GATE)} = 47\text{ nF}$ , LPM = High                                                                                            |     | 3.1 | 4.5 | $\mu\text{s}$ |
| $t_{\text{GATE(UVLO\_OFF)}}$                | UVLO Turn OFF Propagation Delay                                                      | UVLO $\downarrow$ to GATE $\downarrow$ , $C_{L(GATE)} = 47\text{ nF}$ , LPM = High                                                                                          |     | 4   | 6.5 | $\mu\text{s}$ |
| $t_{\text{GATE(UVLO\_ON)}}$                 | UVLO to GATE Turn ON Propagation Delay with CBT pre-biased > VPORF and INP kept high | EN/UVLO $\uparrow$ to GATE $\uparrow$ , $C_{L(GATE)} = 47\text{ nF}$ , INP = 2 V, LPM = High                                                                                |     | 8.5 | 25  | $\mu\text{s}$ |
| $t_{\text{GATE(VS\_OFF)}}$                  | GATE Turn OFF Propagation Delay with VS falling < VPORF and INP, EN/UVLO kept high   | VS $\downarrow$ (cross VPORF) to GATE $\downarrow$ , $C_{L(GATE)} = 47\text{ nF}$ , INP = EN/UVLO = 2V, LPM = High                                                          |     | 25  | 40  | $\mu\text{s}$ |
| $t_{\text{SC}}$                             | Short Circuit Protection propagation Delay in Active Mode                            | $V_{(CS1+-CS1-)} \uparrow V_{(SCP)}$ to GATE $\downarrow$ , $C_{L(GATE)} = 47\text{ nF}$ , $V_{(LPM)} = 2\text{ V}$                                                         |     | 3.9 | 5   | $\mu\text{s}$ |
| $t_{\text{LPM\_SC}}$                        | Short Circuit Protection propagation Delay in LPM (Powerup into LPM with short)      | $V_{(DRN-CS2-)} \uparrow V_{(LPM\_SCP)}$ to GATE $\uparrow$ , $C_{L(GATE)} = 47\text{ nF}$ , $V_{(LPM)} = 0\text{ V}$                                                       |     | 3.1 | 4.5 | $\mu\text{s}$ |
| $t_{\text{GATE(FLT\_ASSERT)}}$              | FLT assertion delay during short circuit                                             | $V_{(CS1+-CS1-)} \uparrow V_{(SCP)}$ to FLT $\downarrow$                                                                                                                    |     | 15  | 21  | $\mu\text{s}$ |
| $t_{\text{GATE(FLT\_DE\_ASSERT)}}$          | FLT de-assertion delay during short circuit                                          | $V_{(CS1+-CS1-)} \downarrow V_{(SCP)}$ to FLT $\uparrow$                                                                                                                    |     | 3.8 |     | $\mu\text{s}$ |
| $t_{\text{GATE(FLT\_ASSERT\_BSTUVLO)}}$     | FLT assertion delay during GATE Drive UVLO                                           | $V_{(GATE-SRC)} \downarrow V_{(BSTUVLOR)}$ to FLT $\downarrow$                                                                                                              |     | 30  |     | $\mu\text{s}$ |
| $t_{\text{GATE(FLT\_DE\_ASSERT\_BSTUVLO)}}$ | FLT de-assertion delay during GATE Drive UVLO                                        | $V_{(GATE-SRC)} \uparrow V_{(BSTUVLOR)}$ to FLT $\uparrow$                                                                                                                  |     | 15  |     | $\mu\text{s}$ |
| $t_{\text{(IDIR\_DELAY)}}$                  | Delay for current direction indication on I_DIR pin                                  | $V_{(SNS)} \uparrow$ or $\downarrow$ to $V_{(I\_DIR)} \uparrow$ or $\downarrow$                                                                                             |     | 6.5 | 10  | $\mu\text{s}$ |

## 6.7 Typical Characteristics

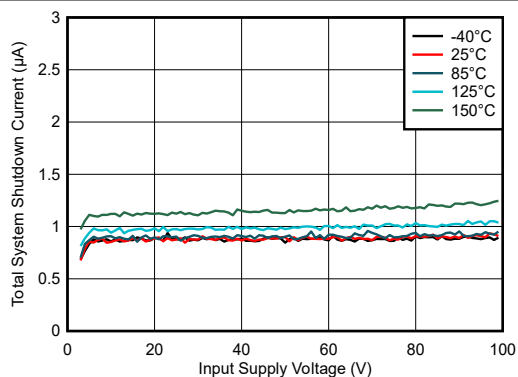


Figure 6-1. Shutdown Supply Current vs Supply Voltage

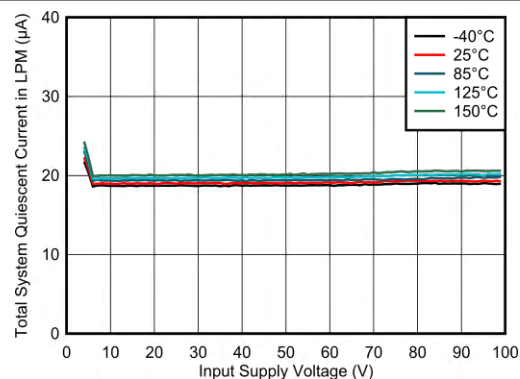


Figure 6-2. Operating Quiescent Current in LPM vs Supply Voltage

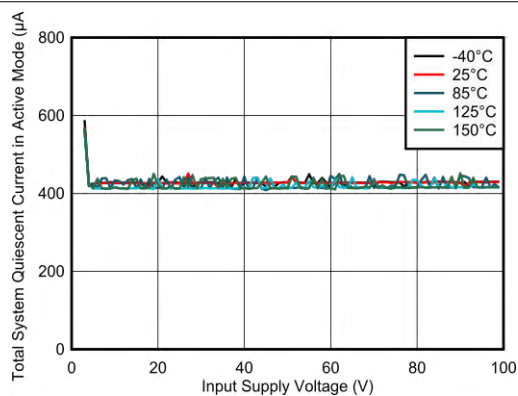


Figure 6-3. Operating Quiescent Current in Active Mode vs Supply Voltage

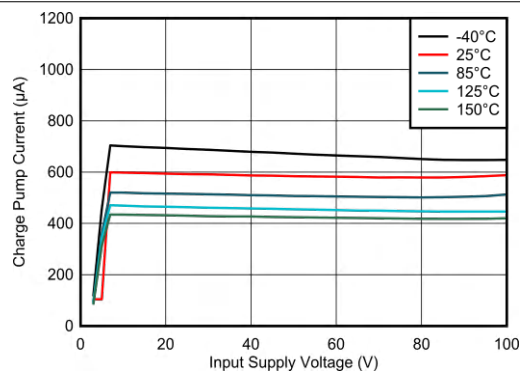


Figure 6-4. Charge Pump Current vs Supply Voltage

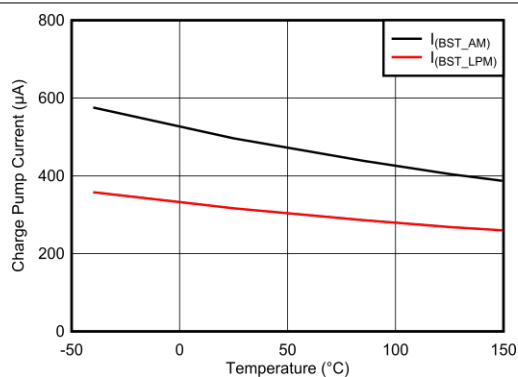


Figure 6-5. Charge Pump Current vs Temperature

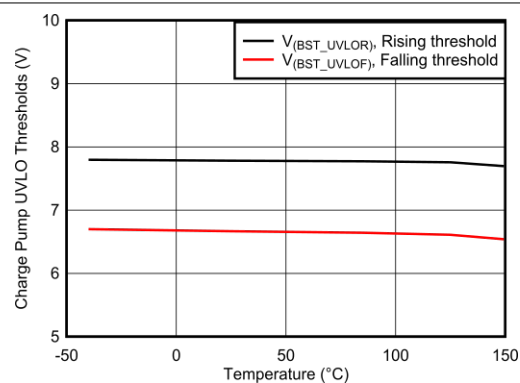
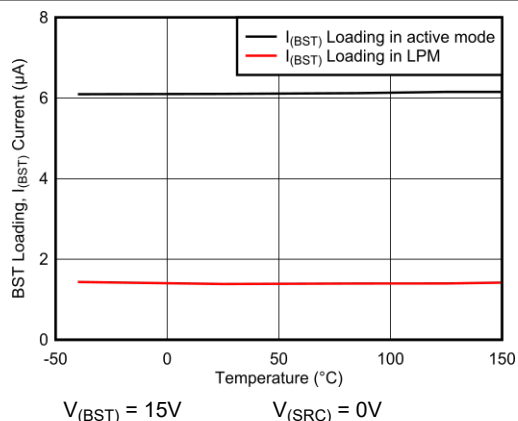
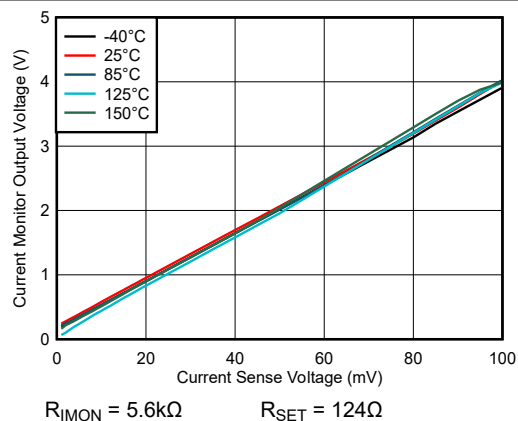


Figure 6-6. Charge Pump UVLO Thresholds vs Temperature

## 6.7 Typical Characteristics (continued)



**Figure 6-7. BST Loading Current ( $I_{BST}$ ) vs Temperature**



**Figure 6-8. Current Monitor Voltage ( $V_{IMON}$ ) vs Sense Voltage ( $V_{SNS}$ )**

## 7 Parameter Measurement Information

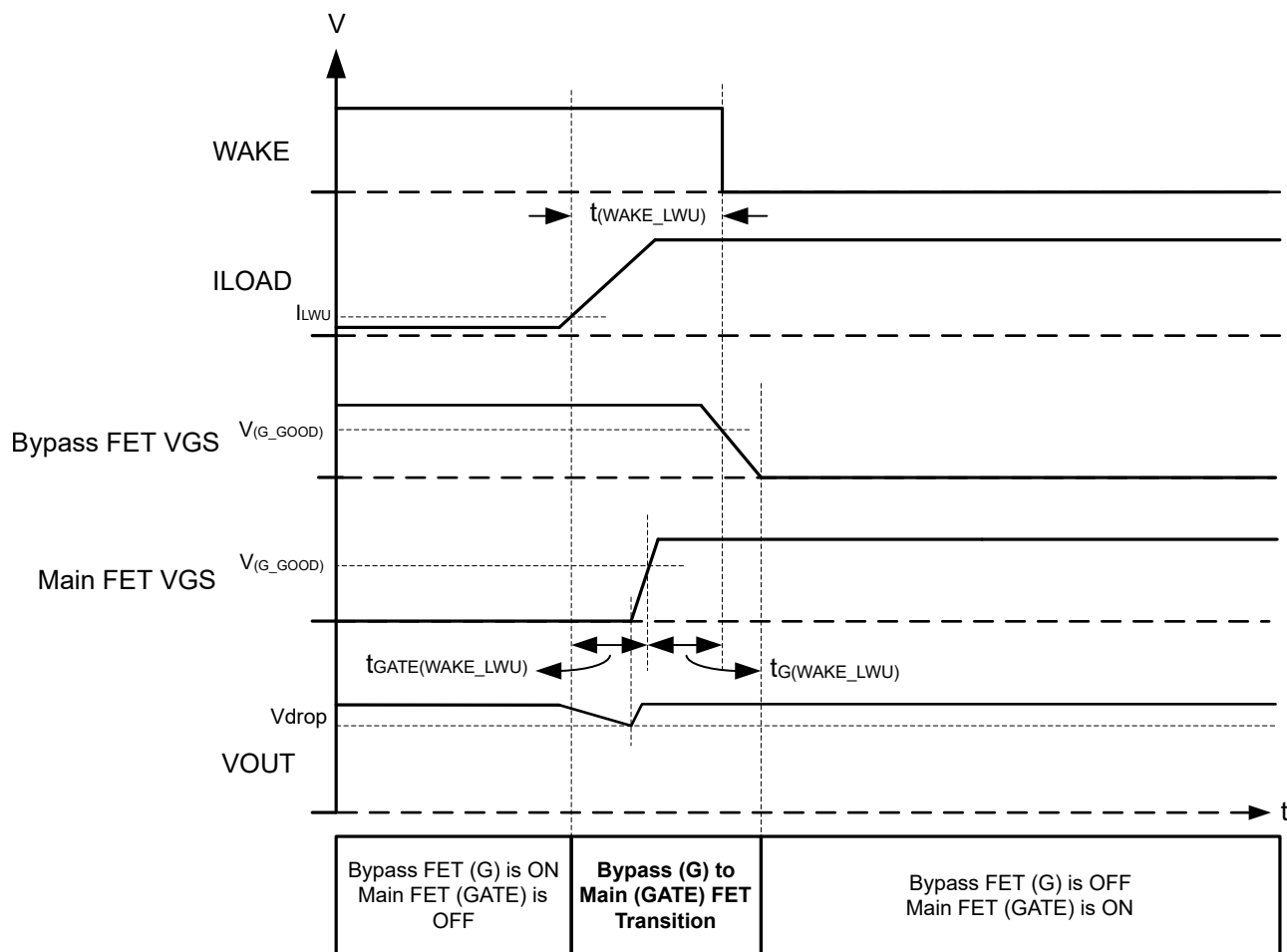


Figure 7-1. System Wake to Active Mode From Low Power Mode by Load Wakeup

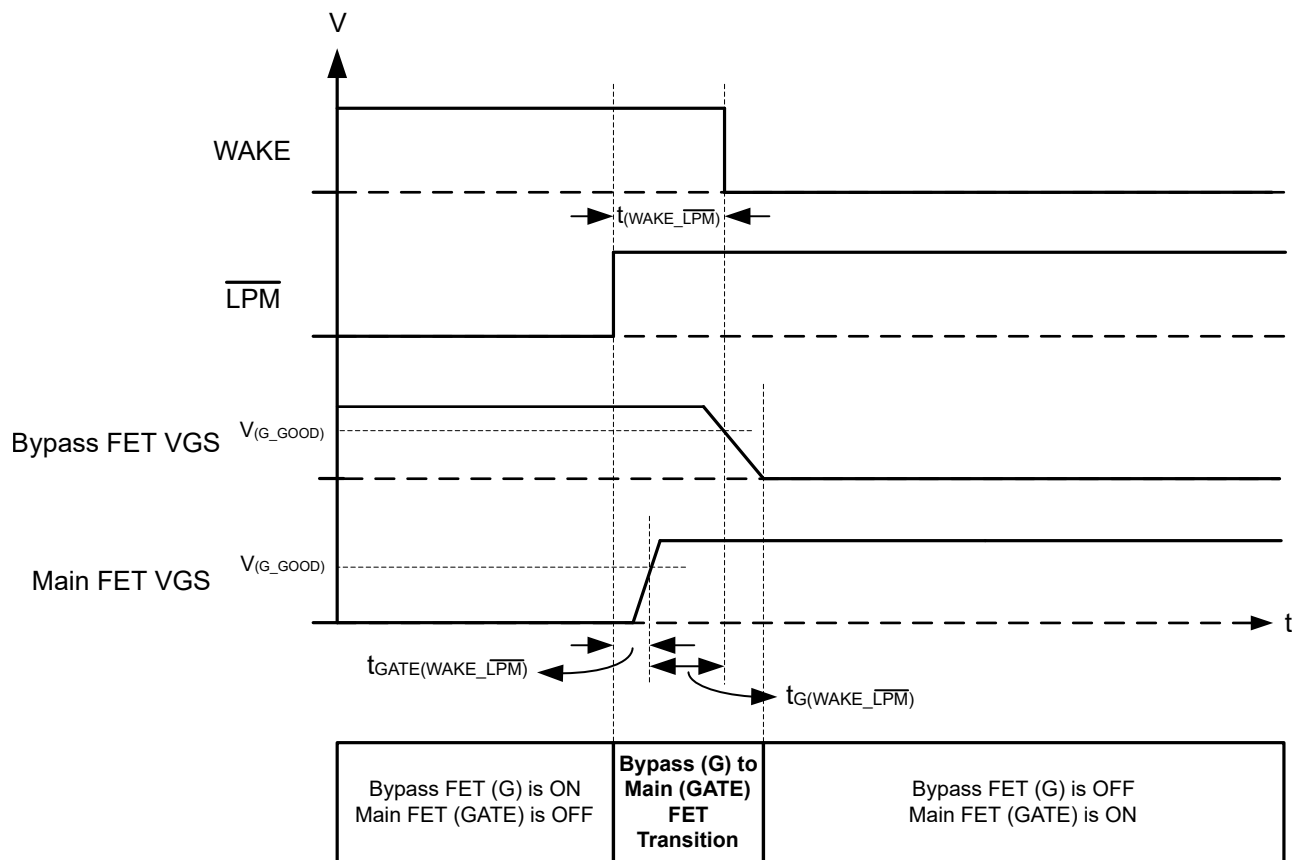
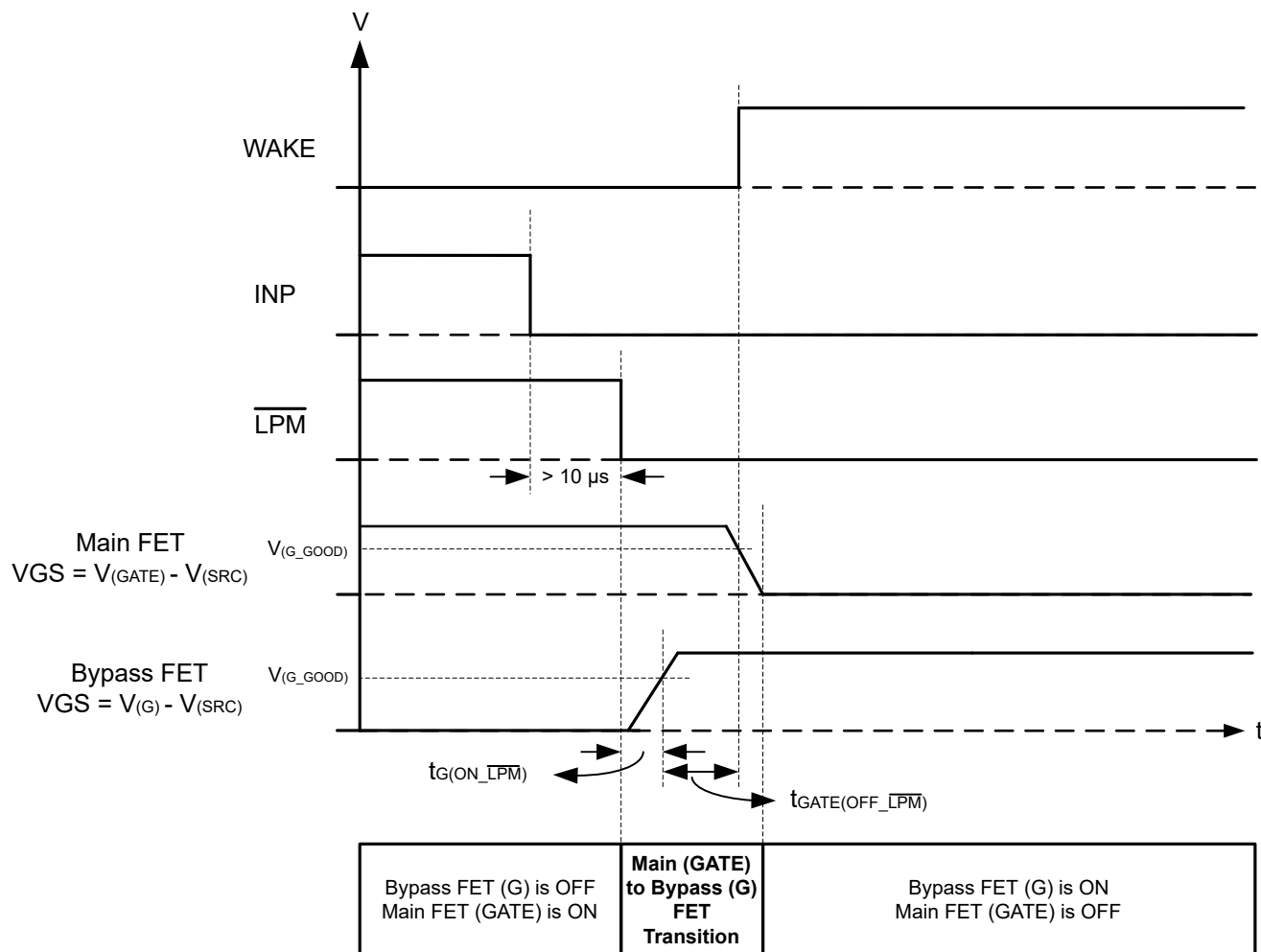


Figure 7-2. System Wake to Active Mode From Low Power Mode by  $\overline{\text{LPM}}$  External Trigger



**Figure 7-3. Active Mode to Low Power Mode by  $\overline{LPM}$  Trigger**

## 8 Detailed Description

### 8.1 Overview

TPS4812-Q1 is a family of low  $I_Q$  smart high side drivers with protection and diagnostics. The TPS4812-Q1 has wide operating voltage range of 3.5V to 95V and 100V absolute-maximum rating. The device is suitable for 12V, 24V, and 48V automotive system designs.

TPS4812-Q1 has two integrated gate drives with 0.5A peak source and 2A sink gate driver to drive FETs in main path and 100 $\mu$ A source and 0.39A sink capacity for the low power path. The strong gate drive (GATE) enables power switching using parallel FETs in high current system designs where INP pin can be used as the GATE control input.

In the low power mode with  $\overline{\text{LPM}} = \text{Low}$ , the low power path FET (G drive) is kept ON and the main FETs (GATE drive) are turned OFF. The device consumes low  $I_Q$  of 20 $\mu$ A (typ) in this mode. Auto load wakeup threshold and output bulk capacitor charging current can be programmed using  $R_{\text{BYPASS}}$  resistor placed across DRN and CS2– pins in low power path.  $I_Q$  reduces to 1 $\mu$ A (typical) with EN/UVLO pulled low. The device features WAKE output pin to indicate the mode of operation (Active/Low power mode).

The device has accurate current sensing ( $\pm 2\%$  at 30mV  $V_{\text{SNS}}$ ) output (IMON) enabling systems for energy management. The device has integrated accurate and adjustable  $I^2t$  based overcurrent and short circuit protection by using an external  $R_{\text{SNS}}$  resistor. Auto-retry and latch-off fault behavior can be configured.

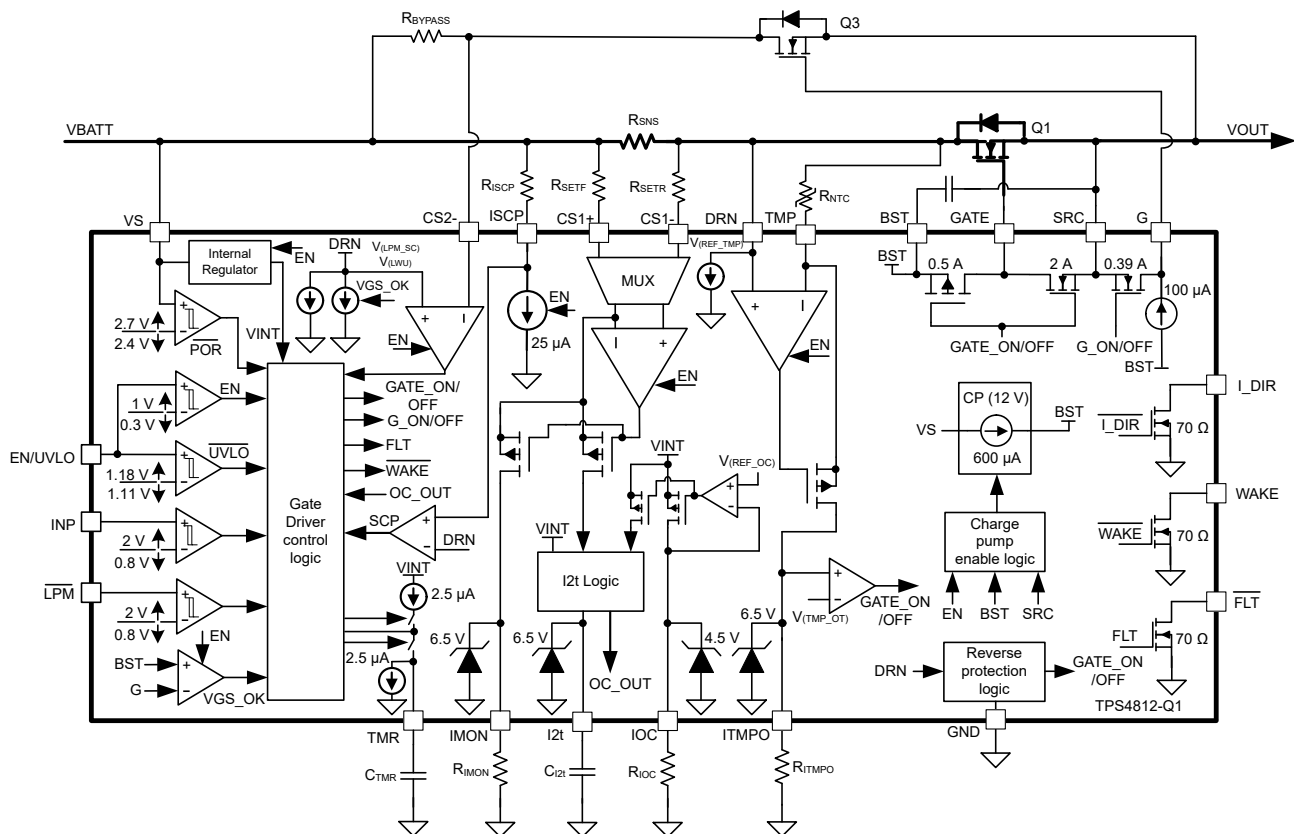
TPS4812-Q1 indicate fault on open drain  $\overline{\text{FLT}}$  output during overcurrent, short circuit, charge pump under voltage and external FET overtemperature conditions.

TPS4812-Q1 has integrated reverse polarity protection down to –65V and do not need any external components to protect the ICs during an input reverse polarity fault.

The device features NTC based temperature sensing (TMP) and monitor output (ITMPO) output to sense overtemperature of external FETs enabling robust thermal system designs.

The TPS4812x-Q1 is available in a 23-pin QFN package.

## 8.2 Functional Block Diagram



## 8.3 Feature Description

### 8.3.1 Charge Pump and Gate Driver Output (VS, GATE, BST, SRC)

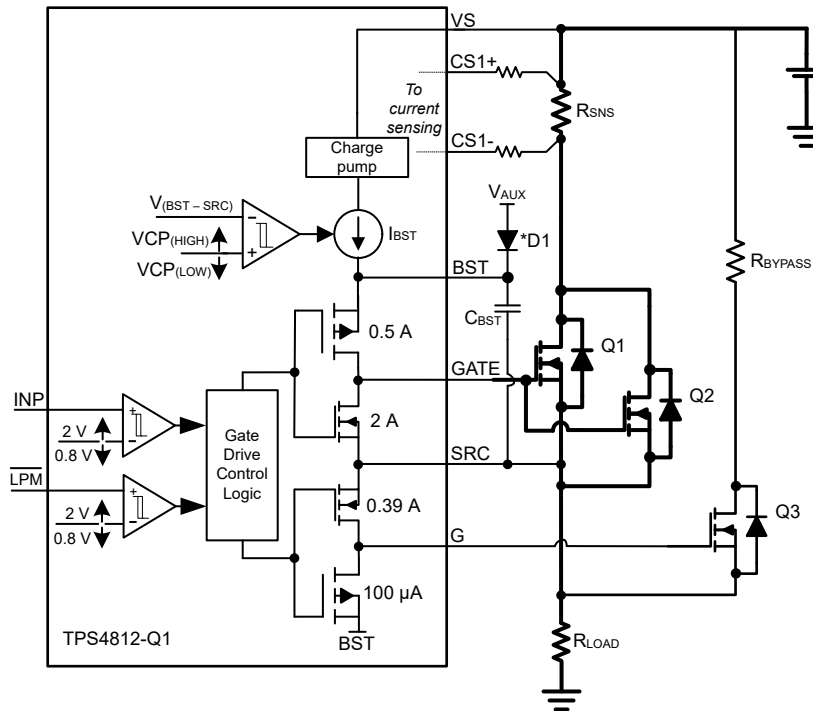
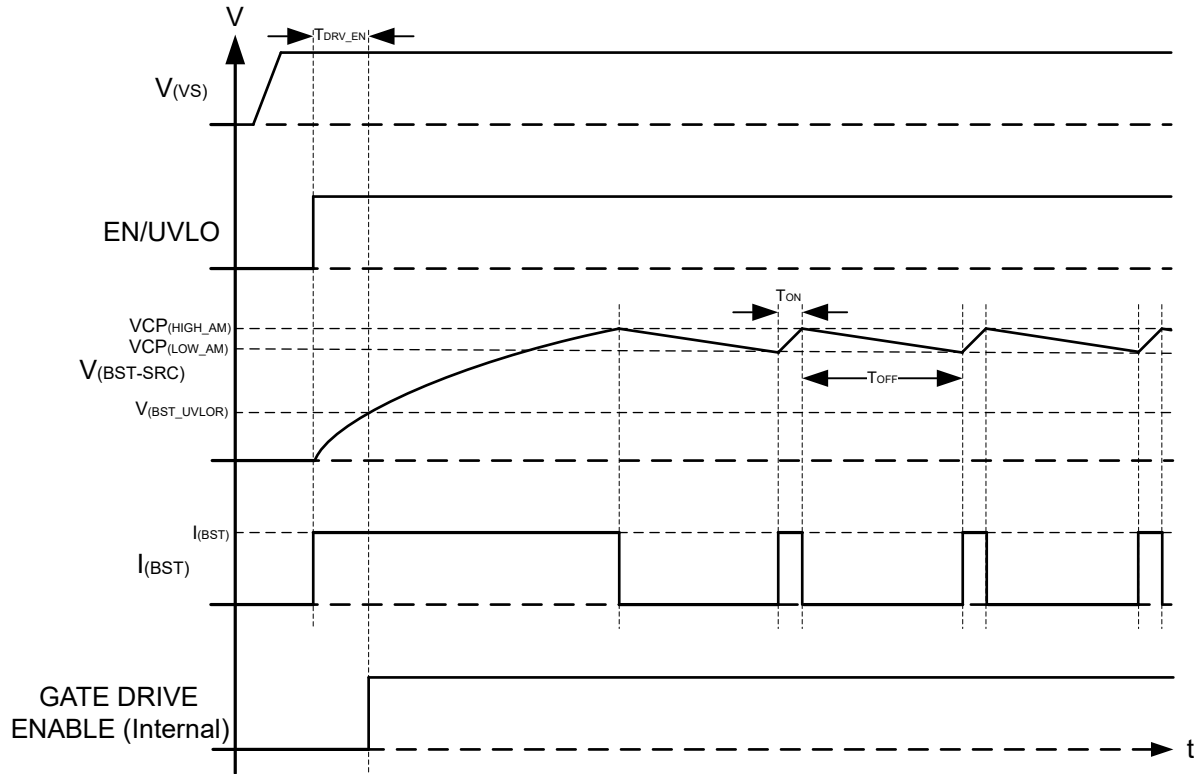


Figure 8-1. Gate Driver

Figure 8-1 shows a simplified diagram of the charge pump and gate driver circuit implementation. The device houses a strong 0.5A/2A peak source/sink gate driver (GATE) for main FETs Q1, Q2, and 100μA/0.39A peak source/sink current gate driver (G) for bypass FET Q3. The strong gate drivers enable paralleling of FETs in high power system designs ensuring minimum transition time in saturation region. A 12V in active mode, 600μA charge pump is derived from VS terminal and charges the external boot-strap capacitor,  $C_{BST}$  that is placed across the gate driver (BST and SRC).

VS is the supply pin to the controller. With VS applied and EN/UVLO pulled high, the charge pump turns ON and charges the  $C_{BST}$  capacitor. After the voltage across  $C_{BST}$  crosses  $V_{(BST\_UVLOR)}$ , the GATE driver section is activated. The device has a 1V (typical) UVLO hysteresis to ensure chattering less performance during initial GATE turn ON. Choose  $C_{BST}$  based on the external FET  $Q_G$  and allowed dip during FET turn ON. In active mode, the charge pump remains enabled until the BST to SRC voltage reaches  $V_{CP(HIGH\_AM)}$ , typically, at which point the charge pump is disabled decreasing the current draw on the VS pin. The charge pump remains disabled until the BST to SRC voltage discharges to  $V_{CP(LOW\_AM)}$  typically at which point the charge pump is enabled.

The voltage between BST and SRC continue to charge and discharge between  $V_{CP(HIGH\_AM)}$  and  $V_{CP(LOW\_AM)}$  in active mode as shown in Figure 8-2:



**Figure 8-2. Charge Pump Operation**

Use [Equation 1](#) to calculate the initial gate driver enable delay:

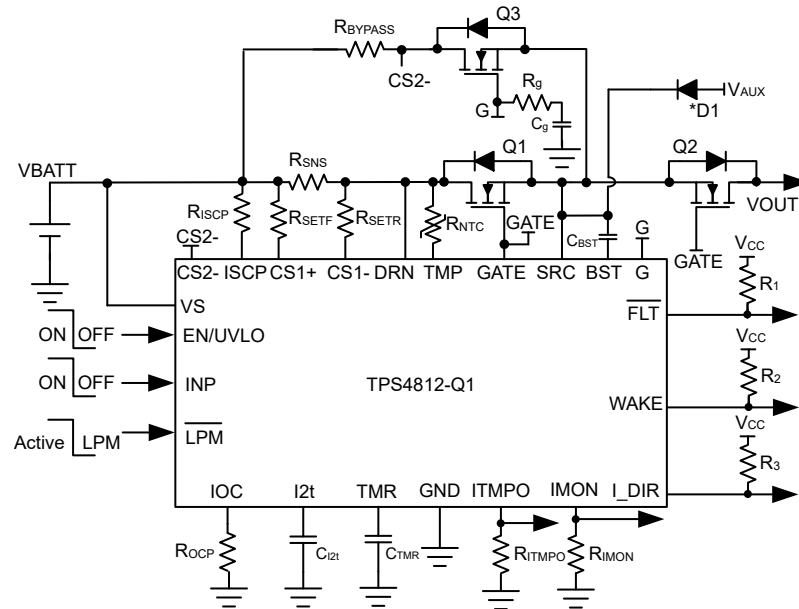
$$T_{DRV\_EN} = \frac{C_{BST} \times V_{(BST\_UVLOR)}}{600 \mu A} \quad (1)$$

Where,

$C_{BST}$  is the charge pump capacitance connected across BST and SRC pins.

$V_{(BST\_UVLOR)} = 7.6V$  (typ).

If  $T_{DRV\_EN}$  needs to be reduced then pre-bias BST terminal externally using an external VAUX or input supply through a low leakage diode D1 as shown in [Figure 8-3](#). With this connection,  $T_{DRV\_EN}$  reduces to 350μs.



**Figure 8-3. TPS4812-Q1 Application Circuit With External Supply to BST**

**Note**

$V_{AUX}$  can be supplied by external supply ranging between 8.1V and 15V. Input supply VS can also be connected to BST via D1 diode for reducing  $T_{DRV\_EN}$ .

### 8.3.2 Capacitive Load Driving

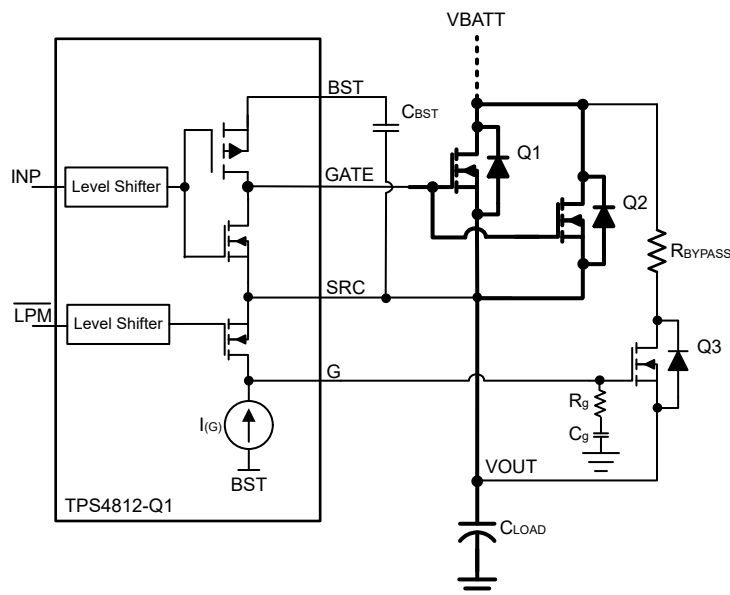
Certain end equipment like automotive power distribution unit and zonal controller power different loads including other ECUs. These ECUs can have large input capacitances. If power to the ECUs is switched on in uncontrolled way, large inrush currents can occur and potentially damaging the power FETs.

To limit the inrush current during capacitive load switching, the following system design techniques can be used with TPS4812-Q1 device.

#### 8.3.2.1 Using Low-Power Bypass FET (G Drive) for Load Capacitor Charging

In high-current applications where several FETs are connected in parallel, the gate slew rate control for the main FETs is not recommended due to unequal distribution of inrush currents among the FETs resulting in over sizing of the FETs.

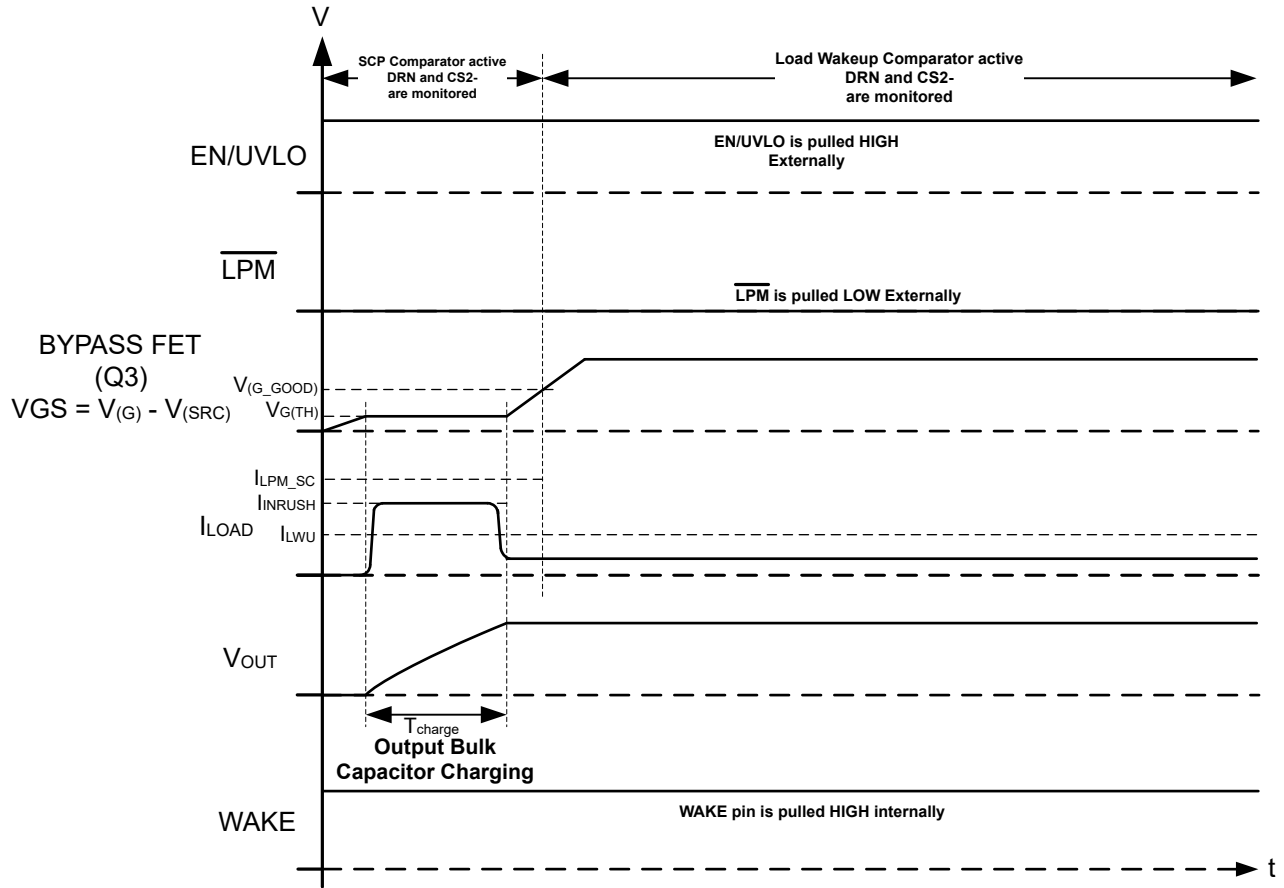
The TPS4812-Q1 integrates gate driver (G) with a dedicated control input ( $\overline{LPM}$ ) and bypass comparator between DRN and CS2- pins. This feature can be used to drive a separate low power bypass FET and pre-charge the capacitive load with inrush current limiting. Figure 8-4 shows the low power bypass FET implementation for capacitive load charging using TPS4812-Q1. An external capacitor  $C_g$  reduces the gate turn ON slew rate and controls the inrush current.



**Figure 8-4. Capacitor Charging Using Gate (G) Slew Rate Control of Low-Power Bypass FET**

During power-up with EN/UVLO pulled high and  $\overline{\text{LPM}}$  pulled low, the device turns ON bypass FET (G) by pulling G high with 100 $\mu\text{A}$  of source current and the main FETs (GATE) is kept OFF. In this low power mode (LPM), TPS4812-Q1 senses voltage between DRN and CS2– pins along with VGS of bypass FET (G to SRC). The voltage across DRN and CS2– is compared initially with  $V_{(\text{LPM\_SCP})}$  threshold (2V typical) to detect powerup into short fault event until  $V_{(\text{G\_GOOD})}$  threshold is reached.

After  $V_{(\text{G\_GOOD})}$  threshold is reached, the voltage between DRN and CS2– is compared against  $V_{(\text{LWU})}$  threshold (200mV typ) for load wakeup event. With this scheme capacitor charging current ( $I_{\text{INRUSH}}$ ) can be set at higher than load wakeup threshold ( $I_{\text{LWU}}$ ) and power-up into short event can also be detected reliably as shown in [Figure 8-5](#).



**Figure 8-5. Timing Diagram for Bulk Capacitor Charging Using Bypass Path**

#### Setting the Load Wakeup Trigger Threshold:

During normal operation, the series resistor  $R_{BYPASS}$  is used to set load wakeup current threshold. After  $V_{(G\_GOOD)}$  threshold is reached, the voltage between DRN and CS2– is compared against  $V_{(LWU)}$  threshold (200mV typ) for load wakeup event.

$R_{BYPASS}$  can be selected using [Equation 2](#):

$$R_{BYPASS} = \frac{V_{(LWU)}}{I_{LWU}} \quad (2)$$

#### Setting the INRUSH Current:

Use [Equation 3](#) to calculate the  $I_{INRUSH}$ :

$$I_{INRUSH} = C_{LOAD} \times \frac{V_{BATT}}{T_{charge}} \quad (3)$$

Where,

$C_{LOAD}$  is the load capacitance.

$V_{BATT}$  is the input voltage and  $T_{charge}$  is the charge time.

$I_{INRUSH}$  should be always less than wakeup in short in low power mode ( $I_{LPM\_SC}$ ) current which can be calculated using [Equation 4](#):

$$I_{LPM\_SC} = \frac{V_{(LPM\_SCP)}}{R_{BYPASS}} \quad (4)$$

Use Equation 5 to calculate the required  $C_g$  value.

$$C_g = \frac{C_{LOAD} \times I_{(G)}}{I_{INRUSH}} \quad (5)$$

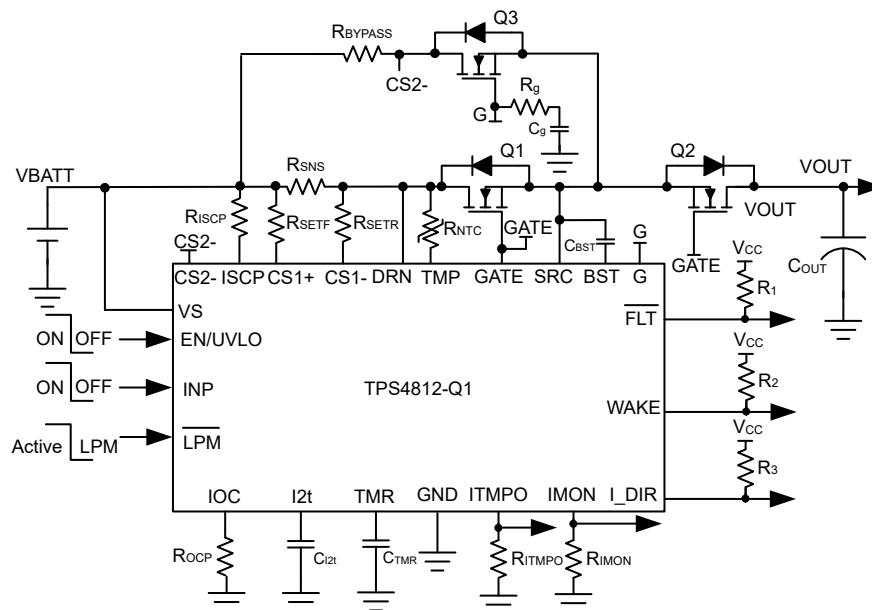
Where,

$I_{(G)}$  is 100 $\mu$ A (typical),

A series resistor  $R_g$  must be used in conjunction with  $C_g$  to limit the discharge current from  $C_g$  during turn-off. The recommended value for  $R_g$  is between 220 $\Omega$  to 470 $\Omega$ .

After the output capacitor is charged, main FETs can be controlled (GATE drive) and bypass FET (G drive) can be turned OFF by driving LPM high externally. The main FETs (G drive) can now be turned ON by driving INP high.

Figure 8-6 shows application circuit to charge large output capacitors using low power bypass path in high current applications.

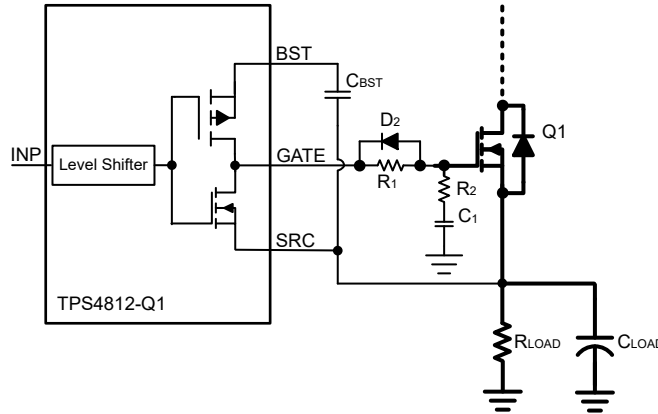


**Figure 8-6. TPS4812-Q1 Application Circuit for Capacitive Load Driving Using Low-Power Bypass FET (Q<sub>3</sub>) and Series Resistor (R<sub>BYPASS</sub>)**

### 8.3.2.2 Using Main FET (GATE Drive) Gate Slew Rate Control

In the applications where low power bypass path is not used, the cap charging can be done using main FET GATE drive control.

For limiting inrush current during turn-ON of the main FET with capacitive loads, use  $R_1$ ,  $R_2$ ,  $C_1$ , and  $D_2$  as shown in Figure 8-7. The  $R_1$  and  $C_1$  components slow down the voltage ramp rate at the gate of main FET. The FET source follows the gate voltage resulting in a controlled voltage ramp across the output capacitors.



**Figure 8-7. Inrush Current Limiting in Main Path**

Use the [Equation 6](#) to calculate the inrush current during turn-ON of the FET.

$$I_{\text{INRUSH}} = C_{\text{LOAD}} \times \frac{V_{\text{BATT}}}{T_{\text{charge}}} \quad (6)$$

$$C_1 = \frac{0.63 \times V_{(\text{BST} - \text{SRC})} \times C_{\text{LOAD}}}{R_1 \times I_{\text{INRUSH}}} \quad (7)$$

Where,

$C_{\text{LOAD}}$  is the load capacitance.

$V_{\text{BATT}}$  is the input voltage and  $T_{\text{charge}}$  is the charge time.

$V_{(\text{BST}-\text{SRC})}$  is the charge pump voltage (12V).

Use a damping resistor  $R_2$  (~10Ω) in series with  $C_1$ . [Equation 8](#) can be used to compute required  $C_1$  value for a target inrush current. A 100kΩ resistor for  $R_1$  can be a good starting point for calculations.

$D_2$  ensures fast turn OFF of GATE drive by bypassing  $R_1$ .

$C_1$  results in an additional loading on  $C_{\text{BST}}$  to charge during turn-ON. Use [Equation 8](#) to calculate the required  $C_{\text{BST}}$  value:

$$C_{\text{BST}} = \frac{Q_{\text{g}(\text{total})}}{\Delta V_{\text{BST}}} + 10 \times C_1 \quad (8)$$

Where,

$Q_{\text{g}(\text{total})}$  is the total gate charge of the FET.

$\Delta V_{\text{BST}}$  (1V typical) is the ripple voltage across BST to SRC pins.

### 8.3.3 Overcurrent and Short-Circuit Protection

TPS4812-Q1 features integrated accurate  $I^2t$  functionality for the implementation of a robust and flexible overcurrent protection mechanism. This  $I^2t$  functionality features an intelligent circuit breaking aimed at protecting PCB traces, connectors and wire harness from overheating, with no impact on load transients like inrush currents and bulk capacitor charging.

The device also features accurate and configurable short-circuit protection threshold ( $I_{SC}$ ) with fixed response time ( $t_{SC} = 5\mu s$  max).

Figure 8-8 shows the overall current-time characteristics.

- Configurable  $I^2t$  based overcurrent protection ( $I_{OC}$ ) threshold and adjustable response time ( $t_{OC}$  and  $t_{OC\_MIN}$ )
- Adjustable short-circuit threshold ( $I_{SC}$ ) with internally fixed fast response ( $t_{SC}$ )

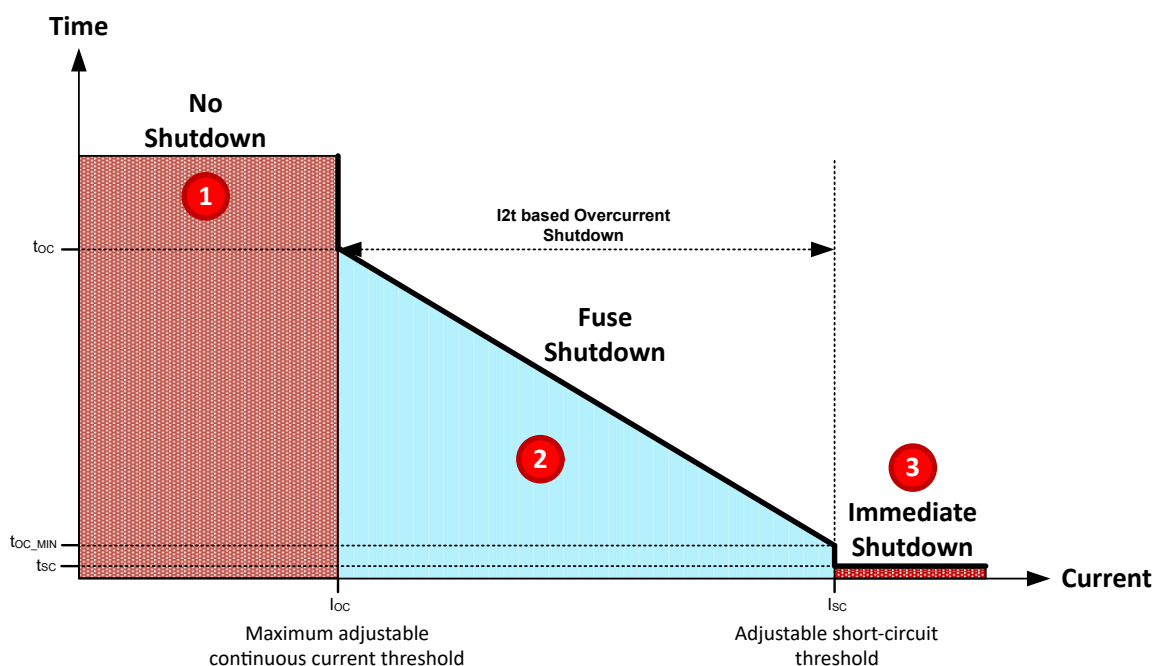


Figure 8-8. Configurable Current vs Time characteristics curve for TPS4812-Q1

### 8.3.3.1 I<sup>2</sup>t-Based Overcurrent Protection

The I<sup>2</sup>t profile for TPS4812-Q1 is set by two parameters which are I<sup>2</sup>t start overcurrent threshold, I<sub>OC</sub> and I<sup>2</sup>t ampere squared second factor (melting point or breaking point). The overcurrent protection time t<sub>OC</sub> is determined based on set I<sup>2</sup>t factor when load current is higher than set I<sub>OC</sub> threshold.

#### Setting I<sup>2</sup>t Protection Starting Threshold, R<sub>IOC</sub>

The I<sup>2</sup>t protection starting threshold I<sub>OC</sub> is set using an external resistor R<sub>IOC</sub> across IOC and GND pins.

Use Equation 9 to calculate the required R<sub>IOC</sub> value:

$$R_{IOC} (\Omega) = \frac{V_{(REF\_OC)}}{K \times (I_{OC})^2} \quad (9)$$

Where,

V<sub>(REF\_OC)</sub> is internal reference voltage of 200mV.

I<sub>OC</sub> is the overcurrent level.

The scaling factor, K can be calculated by Equation 10:

$$\text{Scaling factor } (K) = \frac{\left(0.1 \times \frac{R_{SNS}}{R_{SET}}\right)^2}{I_{BIAS}} \quad (10)$$

Where,

I<sub>BIAS</sub> is internal reference current of 5μA.

R<sub>SET</sub> is the resistor connected across CS1+ and input battery supply.

R<sub>SNS</sub> is the current sense resistor.

#### Setting I<sup>2</sup>t Profile, C<sub>I2t</sub>

The device senses the voltage across the external current sense resistor (R<sub>SNS</sub>) through CS1+ and CS1–. When sensed voltage across R<sub>SNS</sub> exceeds I<sub>OC</sub> threshold set by R<sub>IOC</sub> resistor, C<sub>I2t</sub> capacitor starts charging with current proportional to I<sub>LOAD</sub><sup>2</sup> – I<sub>OC</sub><sup>2</sup> current.

The time to turn OFF the gate drive at maximum overcurrent limit (I<sub>OC\_MAX</sub>) can be determined using Equation 11:

$$t_{OC\_MIN} (s) = \frac{I2T \text{ factor}}{I_{OC\_MAX} \times I_{OC\_MAX}} \quad (11)$$

#### Note

The maximum overcurrent limit (I<sub>OC\_MAX</sub>) can 5% to 10% below short-circuit protection threshold (I<sub>SC</sub>).

Use Equation 12 to calculate the required C<sub>I2t</sub> value.

$$C_{I2t} (F) = \frac{K \times t_{OC\_MIN}}{V_{(I2t\_OC)} - V_{(I2t\_OFFSET)}} \times [I_{OC\_MAX}^2 - I_{OC}^2] \quad (12)$$

Where,

V<sub>(I2t\_OC)</sub> is I<sup>2</sup>t trip threshold voltage of 2V (typ).

V<sub>(I2t\_OFFSET)</sub> is offset voltage of 500mV (typ) on I2t pin during normal operation.

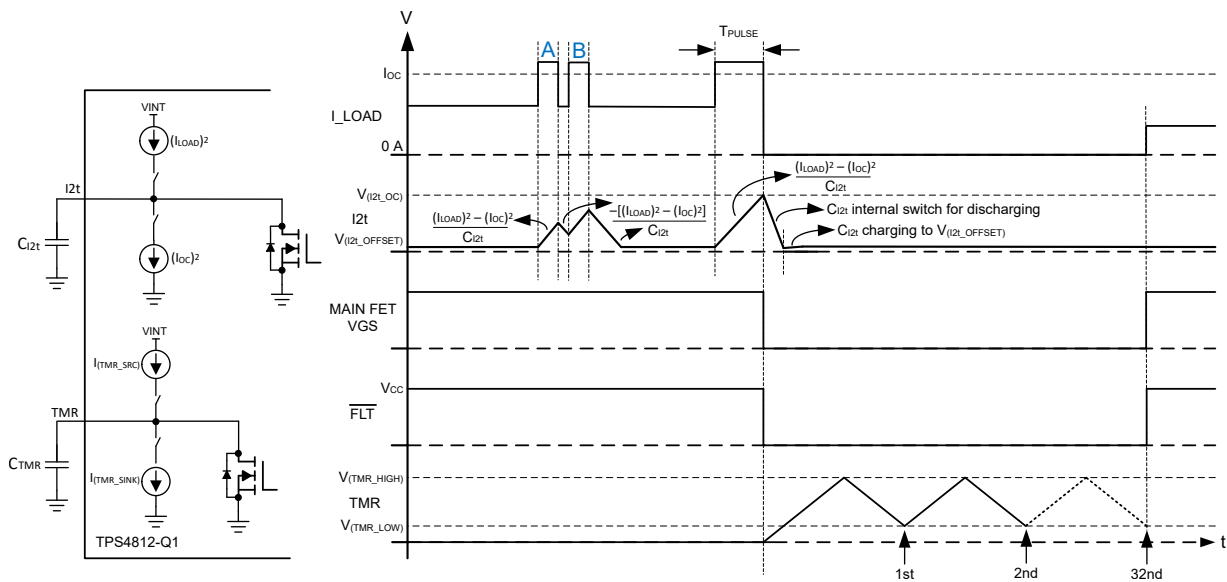
t<sub>OC\_MIN</sub> is the desired overcurrent response time at maximum overcurrent threshold I<sub>OC\_MAX</sub>.

### 8.3.3.1.1 $I^2t$ -Based Overcurrent Protection With Auto-Retry

The  $C_{I2t}$  programs the over current protection delay ( $t_{OC\_MIN}$ ) and  $C_{TMR}$  programs auto-retry time ( $t_{RETRY}$ ). Once the voltage across CS1+ and CS1– exceeds the set point ( $V_{(OCF)}$ ), the  $C_{I2t}$  capacitor starts charging with current proportional to  $I_{LOAD}^2 - I_{OC}^2$  current.

After  $C_{I2t}$  charges to  $V_{(I2t\_OC)}$ , GATE pulls low to SRC turning OFF the main FET and  $\overline{FLT}$  asserts low as same time. Post this event, the auto-retry behavior starts. The  $C_{TMR}$  starts charging with 2.5 $\mu$ A pullup current till voltage reaches  $V_{(TMR\_HIGH)}$  level. After this level, capacitor starts discharging with 2.5 $\mu$ A pulldown current.

After the voltage reaches  $V_{(TMR\_LOW)}$  level, the capacitor starts charging again with 2.5 $\mu$ A pullup. After 32 charging-discharging cycles of  $C_{TMR}$  the FET turns ON back and  $\overline{FLT}$  de-asserts after de-assertion delay.



**Figure 8-9.  $I^2t$ -Based Overcurrent Protection With Auto-Retry**

The auto-retry time can be set by  $C_{TMR}$  capacitor to be connected across TMR and GND pins as per [Equation 13](#).

$$t_{RETRY} (s) = 64 \times C_{TMR} \times \left[ \frac{V_{(TMR\_HIGH)} - V_{(TMR\_LOW)}}{I_{(TMR\_SRC)}} \right] \quad (13)$$

where

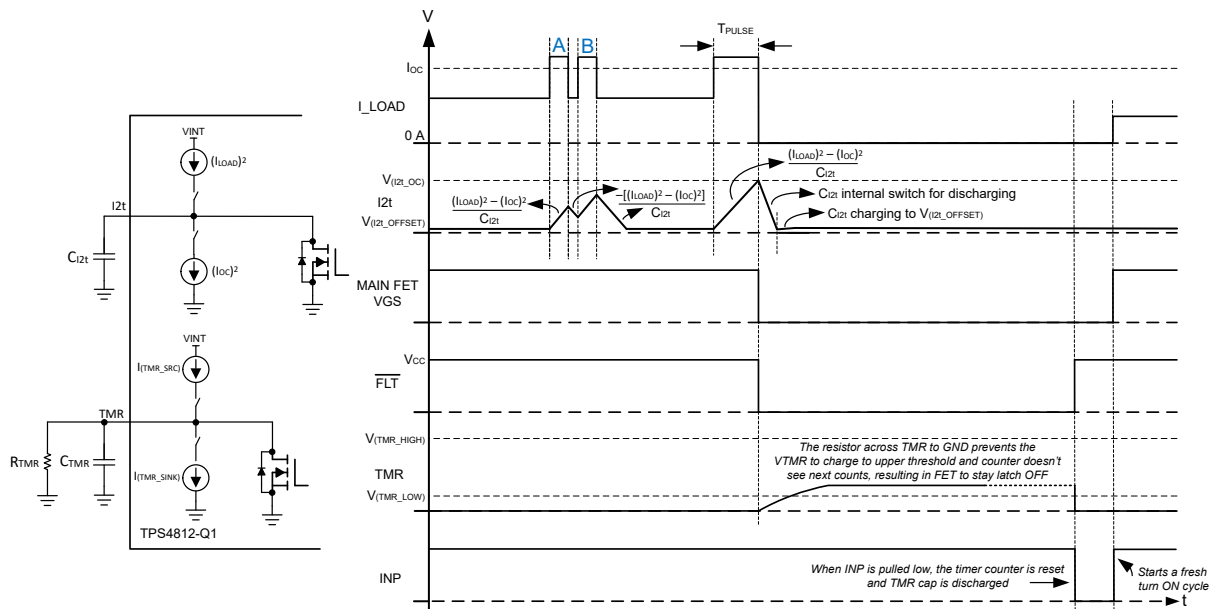
$V_{(TMR\_HIGH)}$  is 1.2V (typ) and  $V_{(TMR\_LOW)}$  is 0.2V (typ).

$I_{(TMR\_SRC)}$  is internal source current on TMR pin with 2.5 $\mu$ A (typ) value.

### 8.3.3.1.2 $I^2t$ -Based Overcurrent Protection With Latch-Off

Connect 100k $\Omega$  resistor across TMR pin to GND for latch-off configuration.

Latch is reset on falling edge of INP or  $\overline{\text{LPM}}$  going low or EN/UVLO (below  $V_{(\text{ENF})}$ ) or power cycle VS below  $V_{(\text{VS\_PORF})}$ . At low edge, the timer counter is reset and  $C_{\text{TMR}}$  is discharged. GATE pulls up to BST when INP is pulled high.



**Figure 8-10.  $I^2t$ -Based Overcurrent Protection With Latch-Off**

### 8.3.3.2 Short-Circuit Protection

The short-circuit current threshold ( $I_{\text{SC}}$ ) can be set  $R_{\text{ISCP}}$  resistor. Use Equation 14 to calculate the required  $R_{\text{ISCP}}$  value.

$$R_{\text{ISCP}} \left( \text{k}\Omega \right) = \frac{I_{\text{SC}} \times R_{\text{SNS}} - 1.8}{I_{\text{SCP}}} \quad (14)$$

where

$I_{\text{SC}}$  is the short-circuit current threshold in Ampere.

$R_{\text{SNS}}$  is external current sense resistor in milliohms.

$I_{\text{SCP}}$  is the internal reference current of 25 $\mu\text{A}$ .

When the load current exceeds the  $I_{\text{SC}}$  threshold then, GATE pulls low to SRC within 5 $\mu\text{s}$  (max) in TPS4812-Q1, protecting the main path FETs and FLT asserts low at the same time. Subsequent to this event, the charge and discharge cycles of  $C_{\text{TMR}}$  starts similar to the behavior post FET OFF event in the overcurrent protection scheme.

Latch-off can also achieved in the similar way as explained in the overcurrent protection scheme.

### 8.3.4 Analog Current Monitor Output (IMON)

TPS4812-Q1 features an accurate analog load current monitor output (IMON) with adjustable gain (ON in active mode and load wakeup only). The current source at IMON terminal is configured to be proportional to the current

flowing through the  $R_{SNS}$  current sense resistor. This current can be converted to a voltage using a resistor  $R_{IMON}$  from IMON terminal to GND pins.

This voltage, computed using following equation, can be used as a means of monitoring current flow through the system.

Use Equation 15 to calculate the  $V_{(IMON)}$  for TPS48120-Q1 variant with  $I^2t$  enabled.

$$V_{(IMON)} = \left( V_{SNS} + V_{(VOS\_SET)} \right) \times \frac{0.9 \times R_{IMON}}{R_{SET}} \quad (15)$$

Use Equation 16 to calculate the  $V_{(IMON)}$  for TPS48121-Q1 variant with  $I^2t$  disabled.

$$V_{(IMON)} = \left( V_{SNS} + V_{(VOS\_SET)} \right) \times \frac{R_{IMON}}{R_{SET}} \quad (16)$$

Where,

$$V_{SNS} = I_{LOAD} \times R_{SNS},$$

$V_{(OS\_SET)}$  is the input referred offset ( $\pm 140\mu V$ ) of the current sense amplifier ( $V_{SNS}$  to  $V_{(IMON)}$  scaling),

0.9 is the current mirror factor between the current sense amplifier and the IMON pass FET.

The maximum voltage range for monitoring the current ( $V_{(IMONmax)}$ ) is limited to minimum( $[V_{(VS)} - 0.5V]$ , 5.5V)

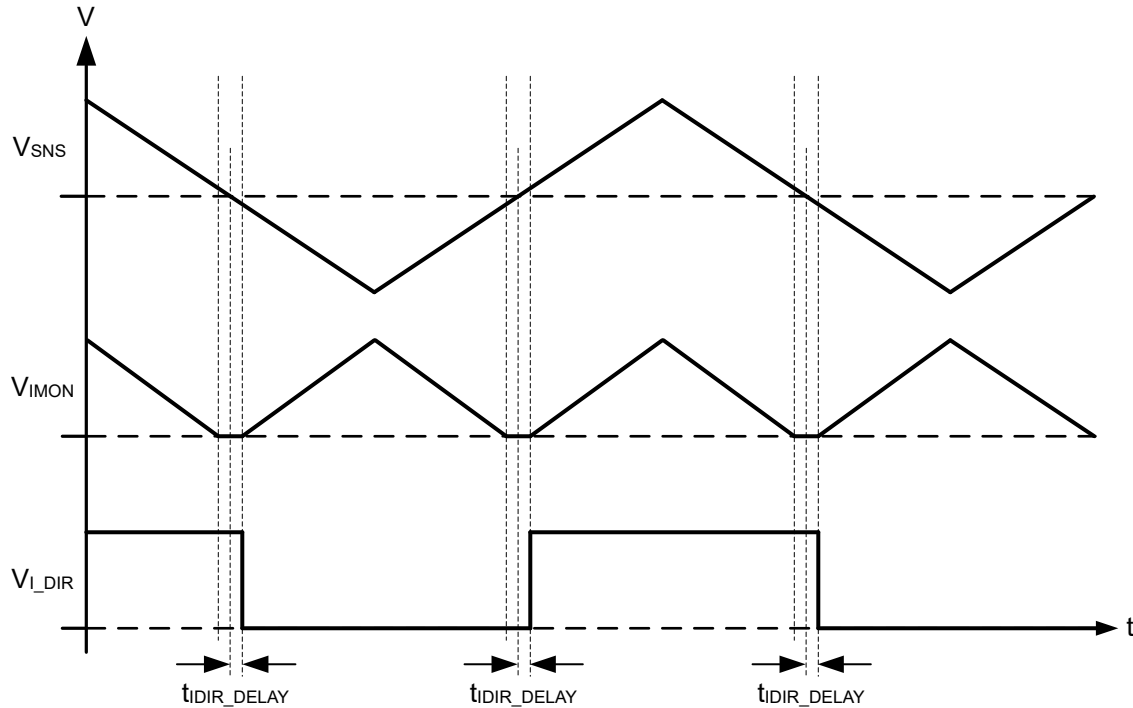
to ensure linear output. This puts limitation on maximum value of  $R_{IMON}$  resistor. The IMON pin has an internal clamp of 6.5V (typical).

Accuracy of the current mirror factor is  $< \pm 1\%$ . Use the following equation to calculate the overall accuracy of  $V_{(IMON)}$ .

$$\% V_{(IMON)} = \frac{V_{(OS\_SET)}}{V_{SNS}} \times 100 \quad (17)$$

TPS4812-Q1 features bi-directional current sensing (across CS1+ and CS1-) and monitoring using IMON output to get magnitude of scaled voltage across  $R_{SNS}$  ( $V_{SNS}$ ) and open drain  $I\_DIR$  output pin indicating direction of current.

$I\_DIR$  output is pulled high if current is flowing in forward direction whereas  $I\_DIR$  is pulled low for reverse current as shown in below figure.



**Figure 8-11. TPS4812-Q1 Bi-directional Current Monitoring Timing Diagram**

### 8.3.5 NTC-Based Temperature Sensing (TMP) and Analog Monitor Output (ITMPO)

TPS4812-Q1 features an integrated temperature monitoring amplifier (ON in active mode and load wakeup only). This temperature monitoring function is implemented with a differential amplifier with input pin as TMP and output pin as ITMPO.

The analog output voltage,  $V_{ITMPO}$  represents the temperature sensed by  $R_{NTC}$  which can be directly read on pin ITMPO (Temperature monitoring output) by microcontroller.

$V_{ITMPO}$  can be calculated based on following equation:

$$V_{ITMPO} = (V_{REF\_TMP} + V_{TMP\_OFFSET}) \times \frac{R_{ITMPO}}{(R_{NTC} + R_{TMP})} \quad (18)$$

where,

$V_{REF\_TMP}$  is 500mV (typical)

$V_{TMP\_OFFSET}$  is  $\pm 5$ mV

$R_{TMP}$  is 330 $\Omega$  for 10k NTC at 25°C

$R_{TMP}$  is 1k $\Omega$  for 47k NTC at 25°C

TPS4812-Q1 has integrated comparator on ITMPO pin to detect external main FET overtemperature fault. When voltage on ITMPO exceeds above  $V_{(TMP\_OT)}$  (2V typ) threshold then main FET (GATE) turns off, device goes into latch-off and  $\overline{FLT}$  asserts low. Latch is reset on falling edge of INP or  $\overline{LPM}$  going low or EN/UVLO (below  $V_{(ENF)}$ ) or power cycle VS below  $V_{(VS\_PORF)}$ .

External FET overtemperature threshold can be programmed based on following equation:

$$V_{(TMP\_OT)} = (V_{REF\_TMP} + V_{TMP\_OFFSET}) \times \frac{R_{ITMPO} + R_{INT}}{(R_{NTC} + R_{TMP})} \quad (19)$$



## 8.4 Device Functional Modes

### 8.4.1 State Diagram

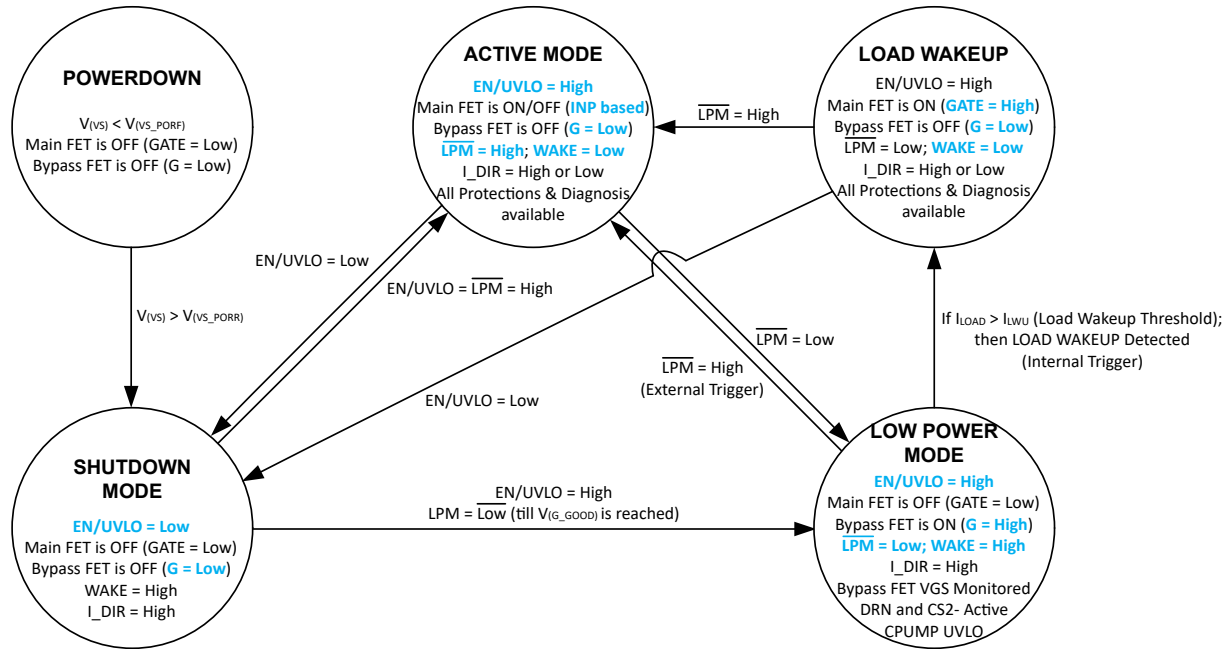


Figure 8-14. State Diagram

### 8.4.2 State Transition Timing Diagram

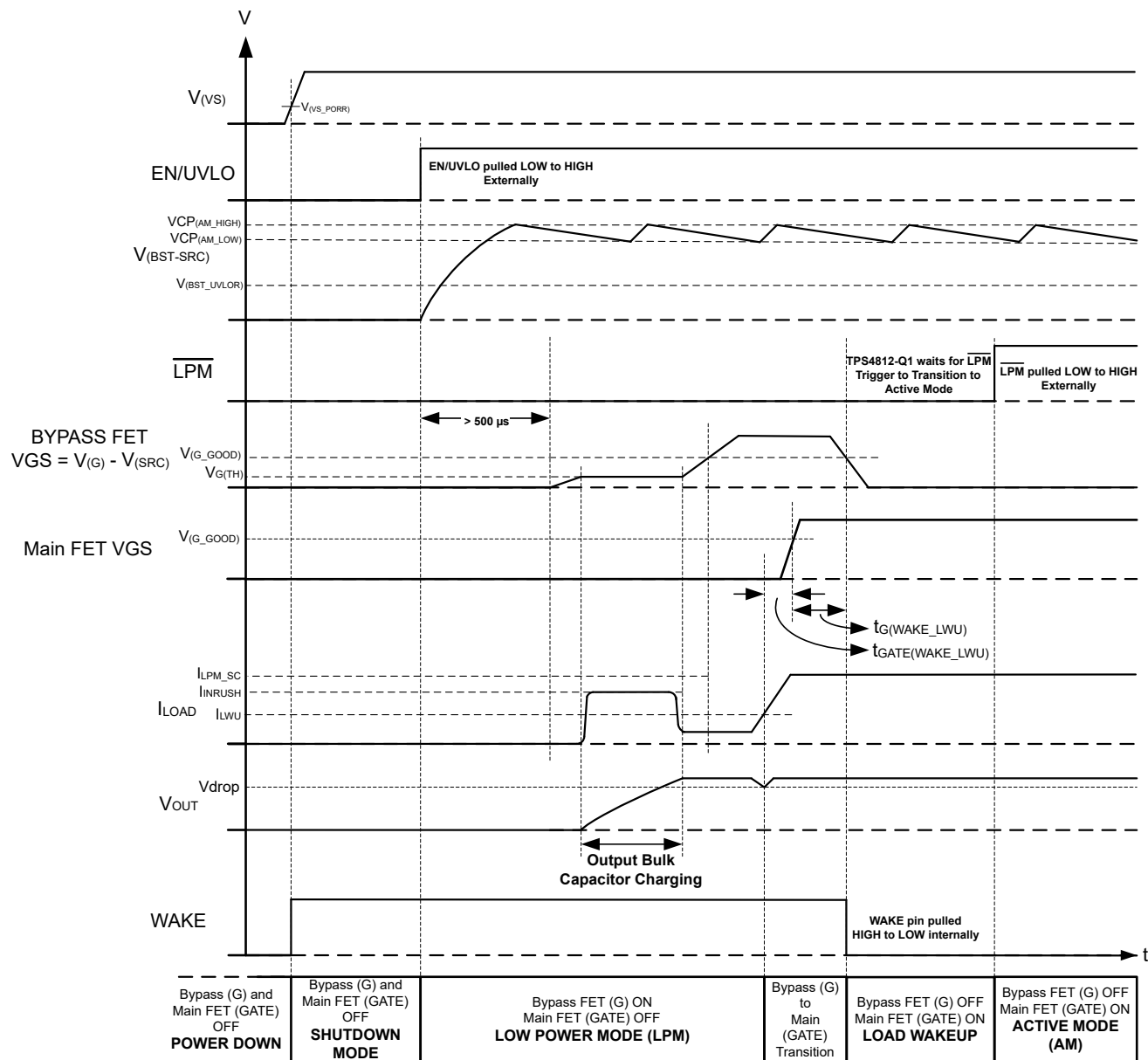
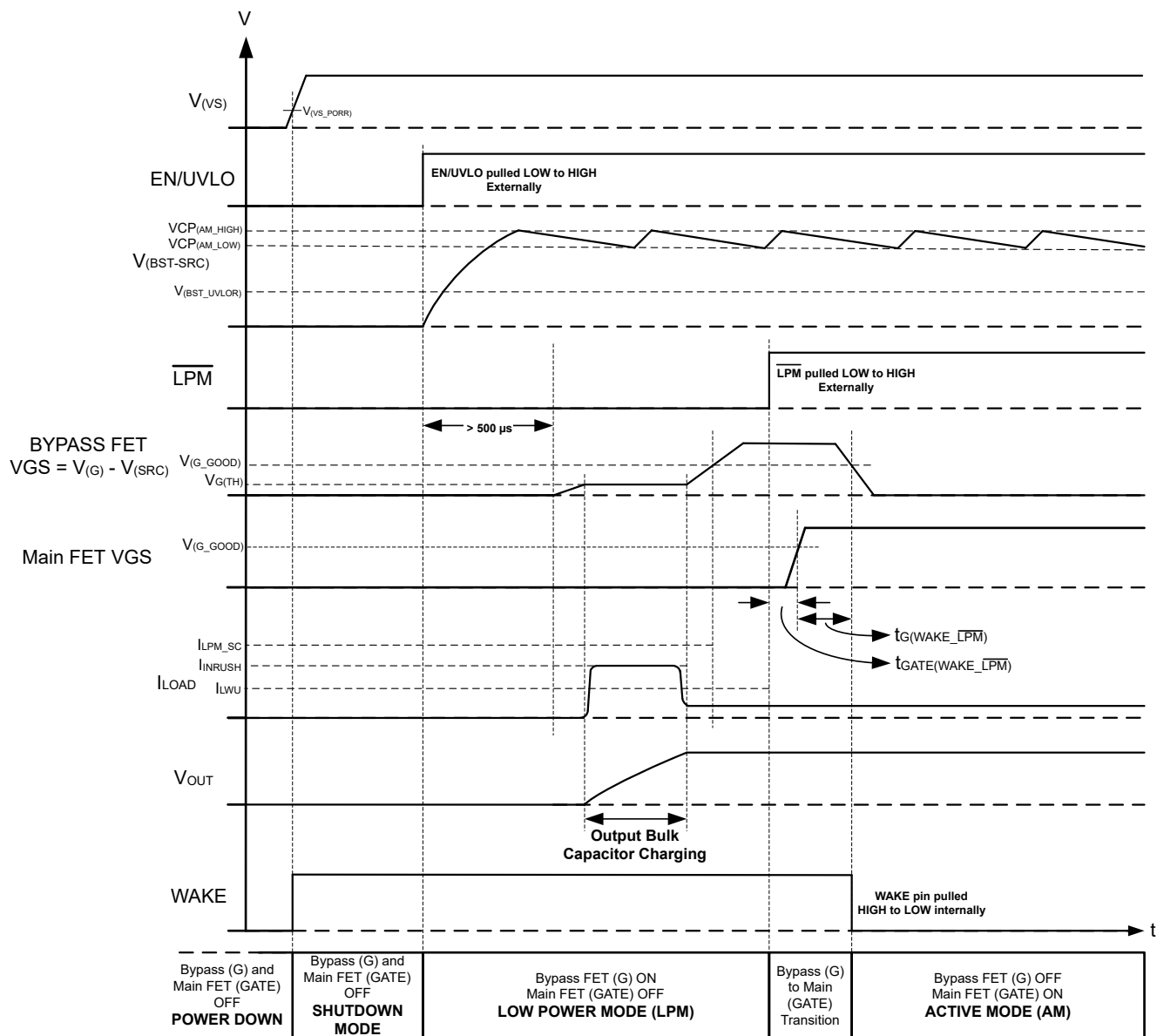
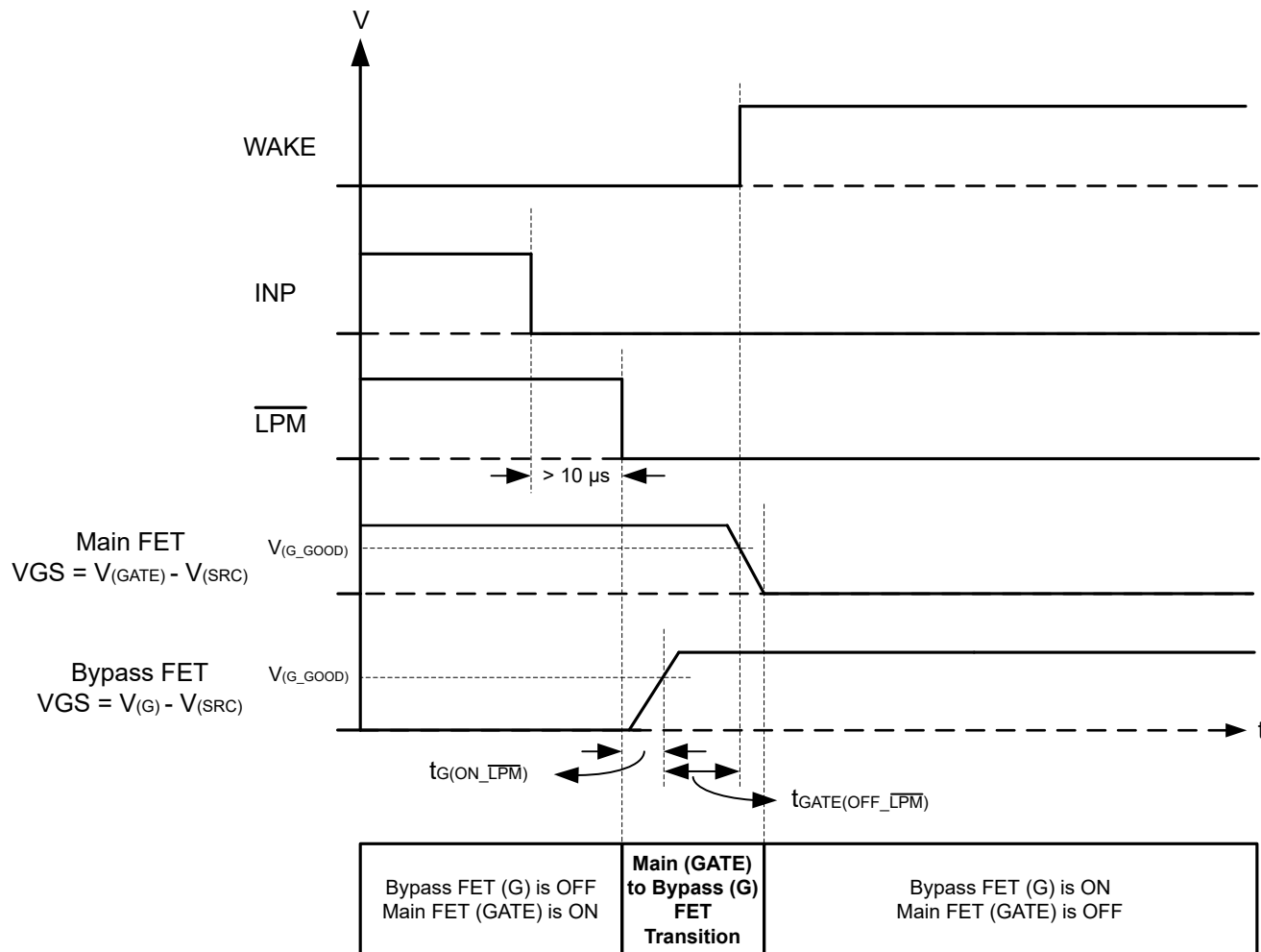


Figure 8-15. State Transition Timing Diagram With Load Wakeup Event



**Figure 8-16. State Transition Timing Diagram With LPM Trigger**



**Figure 8-17.  $\overline{\text{LPM}}$  and INP Signal Sequencing Consideration to Enter Into Low Power Mode From Active Mode**

#### 8.4.3 Power Down

If applied VS voltage is below  $V_{(\text{VS\_PORF})}$  then the device is in disabled state. In this mode, the charge pump and all the protection features are disabled. Both the gate drive outputs (GATE and G) are low.

#### 8.4.4 Shutdown Mode

With  $\text{VS} > V_{(\text{VS\_PORR})}$  and  $\text{EN/UVLO}$  pulled  $< V_{(\text{ENF})}$ , the device transitions to low  $I_Q$  shutdown mode. In this mode, the charge pump and all the protection features are disabled. Both the gate drive outputs (GATE and G) are low. The device consumes low  $I_Q$  of 1 $\mu\text{A}$  (typical) in this mode.

- Shutdown to Low Power Mode:**

To transition from shutdown to low power mode, drive EN/UVLO high ( $> V_{(\text{ENR})}$ ) and simultaneously drive  $\overline{\text{LPM}}$  low for  $> 500\mu\text{s}$ .

- Shutdown to Active Mode:**

To transition from shutdown to active mode directly, drive EN/UVLO and  $\overline{\text{LPM}}$  together high at same time.

#### 8.4.5 Low Power Mode (LPM)

The device transitions from shutdown to low power mode when EN/UVLO is driven high ( $> V_{(\text{ENR})}$ ) and  $\overline{\text{LPM}}$  is driven low for  $> 500\mu\text{s}$  simultaneously.

The device can also transition from active mode to low power mode when  $\overline{\text{LPM}}$  is pulled low. When entering from active mode to low power mode,  $\overline{\text{LPM}}$  and INP signal sequencing consideration can be followed as per [Figure 8-17](#). Pulling INP low before  $\overline{\text{LPM}}$  results in main FET (GATE drive) turning OFF which can cause output voltage droop momentarily before bypass FET (G drive) turns ON. Pulling INP low after at least 10 $\mu$ s of  $\overline{\text{LPM}}$  is pulled low makes a seamless transition from active to low power mode without any output voltage dip.

In this mode, charge pump and G gate drive are enabled. The main FET (GATE drive) is OFF and bypass FET (G drive) is turned ON and WAKE pin asserts high in this state. TPS4812-Q1 consumes low  $I_Q$  of 20 $\mu$ A (typical) in low power mode.

The device transitions from low power mode to active mode when:

- **External Trigger:**  $\overline{\text{LPM}}$  is pulled high externally
- **Internal Trigger:** Load current exceeds load wakeup trigger threshold ( $I_{LWU}$ )

After load current exceeds load wakeup threshold ( $I_{LWU}$ ), the device automatically turns ON main FET (GATE drive) first and bypass FET (G drive) is turned OFF after main FET (GATE drive) has fully turned ON and WAKE asserts low indicating the exit from the low power mode.

The device waits for external  $\overline{\text{LPM}}$  signal to go high to transition into Active mode.

Protections available in low power mode are:

- **Input UVLO:** Bypass FET (G drive) is turned OFF when voltage on EN/UVLO falls below  $V_{(UVLOF)}$ .
- **Charge pump UVLO:** Bypass FET (G drive) is turned OFF when voltage between BST to SRC falls below  $V_{(BST\_UVLOF)}$  and  $\overline{\text{FLT}}$  asserts low.
- **Bypass FET Short-circuit Protection (Wakeup in short):** This protection is available until VGS of bypass FET (G to SRC) reaches  $V_{G\_GOOD}$  threshold. If voltage across DRN and CS2– exceeds the set short-circuit threshold  $V_{(LPM\_SCP)}$  then, the device transitions to LOAD WAKEUP state by turning ON main FET (GATE drive) within  $t_{LPM\_SC}$  time.

In LOAD WAKEUP state if load current is still high and exceeds set short-circuit threshold ( $V_{SCP}$ ) then, the device turns OFF main path (GATE drive) and bypass FET (G drive) within  $t_{SC}$  time. The device goes in auto-retry or latch-off based on the selected configuration and  $\overline{\text{FLT}}$  asserts low.

#### 8.4.6 Active Mode (AM)

The device transitions from shutdown mode to active mode directly when EN/UVLO and  $\overline{\text{LPM}}$  are driven high together at same time.

TPS4812-Q1 transitions from low power mode into active mode by:

- **External Trigger:** Drive  $\overline{\text{LPM}}$  high externally.
- **Internal Trigger:** After load current exceeds load wakeup threshold ( $I_{LWU}$ ), TPS4812-Q1 automatically turns ON main FET (GATE drive) and turns OFF the bypass FET (G drive). Drive  $\overline{\text{LPM}}$  high after load wakeup event to switch to active mode.

In this mode, charge pump, gate drivers and all protections are enabled. The main FET (GATE drive) can be tuned ON or OFF by driving INP high or low respectively and bypass FET (G drive) is turned OFF and WAKE pin asserts low in this state.

The device exits active mode and enters low power mode when  $\overline{\text{LPM}}$  is pulled low.

Protections available in active state are:

- **Input UVLO:** Main FET (GATE drive) is turned OFF when voltage on EN/UVLO falls below  $V_{(UVLOF)}$ .
- **Charge pump UVLO:** Main FET (GATE drive) is turned OFF when voltage between BST to SRC falls below  $V_{(BST\_UVLOF)}$  and  $\overline{\text{FLT}}$  asserts low.
- **Main path  $I^2t$  protection:** Main FET (GATE drive) is turned OFF when voltage across CS1+ and CS1– remains above  $I^2t$  start threshold ( $V_{(OCP)}$ ) for time set by the  $I^2t$  factor based on  $C_{I2t}$ . The device goes in auto-retry or latch-off based on the selected configuration and  $\overline{\text{FLT}}$  asserts low.

- **Main path Short-circuit protection:** Main FET (GATE drive) is turned OFF when voltage across CS1+ and CS1– exceeds the set short-circuit threshold ( $V_{SCP}$ ). The device goes in auto-retry or latch-off based on the selected configuration and  $\overline{FLT}$  asserts low.



### 9.2.2 Detailed Design Procedure

#### Selection of Current Sense Resistor, $R_{SNS}$

The recommended range of the  $I^2t$  based overcurrent protection threshold voltage,  $V_{(SNS\_OCP)}$ , extends from 6mV to 200mV. Values near the low threshold of 6mV can be affected by the system noise. Values near the upper threshold of 200mV can cause high power dissipation in the current sense resistor. To minimize both the concerns, 20mV is selected as the  $I^2t$  protection start threshold voltage. The current sense resistor,  $R_{SNS}$  can be calculated using following equation:

$$R_{SNS} = \frac{V_{(SNS\_OCP)}}{I_{OC}} \quad (20)$$

For 40A ( $I_{OC}$ ) of  $I^2t$  protection start threshold,  $R_{SNS}$  is calculated to be 0.5m $\Omega$ ,

Two of 1m $\Omega$ , 1% sense resistor can be used in parallel.

#### Selection of IMON Scaling Resistor, $R_{SET}$

$R_{SET}$  is the resistor connected between VS or input supply and CS1+ pins. This resistor scales the  $I^2t$  based overcurrent protection threshold voltage and coordinates with  $R_{IOC}$ , charging current on  $C_{I2t}$  and  $R_{IMON}$  to determine the  $I^2t$  profile and current monitoring output.

The maximum current on  $I^2t$  pin can be calculated based on short-circuit protection ( $I_{SC}$ ) threshold based on following equation:

$$I_{I2t\_MAX} (\mu A) = K \times I_{SC}^2 \quad (21)$$

where scaling factor, K can be calculate based on below equation:

$$\text{Scaling factor } \left( K \right) = \frac{\left( 0.1 \times \frac{R_{SNS}}{R_{SET}} \right)^2}{I_{BIAS}} \quad (22)$$

$R_{SET}$  needs to adjusted so that  $I_{I2t\_MAX}$  is always less than 100 $\mu$ A. The recommended range of  $R_{SET}$  is 100 $\Omega$ –500 $\Omega$ .

$R_{SET}$  is selected as 300 $\Omega$ , 1% for this design example to get  $I_{I2t\_MAX}$  current <100 $\mu$ A.

#### Choosing the Current Monitoring Resistor, $R_{IMON}$

Voltage at IMON pin  $V_{(IMON)}$  is proportional to the output load current. This can be connected to an ADC of the downstream system for monitoring the operating condition and health of the system. The  $R_{IMON}$  must be selected based on the maximum load current and the input voltage range of the ADC used.  $R_{IMON}$  is set using following equation:

$$V_{(IMON)} = \left( V_{SNS} + V_{(VOS\_SET)} \right) \times \frac{0.9 \times R_{IMON}}{R_{SET}} \quad (23)$$

Where  $V_{SNS} = I_{OC\_MAX} \times R_{SNS}$  and  $V_{(VOS\_SET)}$  is the input referred offset ( $\pm 150\mu$ V) of the current sense amplifier. For  $I_{OC\_MAX} = 120$ A and considering the operating range of ADC to be 0V to 3.3V (for example,  $V_{(IMON)} = 3.3$ V),  $R_{IMON}$  is calculated to be 18.33k $\Omega$ .

Selecting  $R_{IMON}$  value less than shown in [Equation 23](#) ensures that ADC limits are not exceeded for maximum value of load current. Choose the closest available standard value: 18.2k $\Omega$ , 1%

#### Selection of Main path MOSFETs, Q1 and Q2

Q1 and Q2 For selecting the MOSFET Q1 and Q2, important electrical parameters are the maximum continuous drain current  $I_D$ , the maximum drain-to-source voltage  $V_{DS(MAX)}$ , the maximum drain-to-source voltage  $V_{GS(MAX)}$ , and the drain-to-source ON resistance  $R_{DS(ON)}$ . The maximum continuous drain current rating ( $I_D$ ) must exceed the maximum continuous load current. The maximum drain-to-source voltage,  $V_{DS(MAX)}$ , must be high enough to withstand the highest voltage seen in the application. Considering 60V as the maximum application voltage due to load dump, MOSFETs with VDS voltage rating of 80V is chosen for this application.

The maximum VGS TPS4812-Q1 can drive is 12V, so a MOSFET with 15V minimum VGS rating must be selected.

To reduce the MOSFET conduction losses, an appropriate  $R_{DS(ON)}$  is preferred. Based on the design requirements, two of IAUS200N08S5N023 are selected and its ratings are:

- 80V  $V_{DS(MAX)}$  and  $\pm 20V$   $V_{GS(MAX)}$
- $R_{DS(ON)}$  is 2.3m $\Omega$  typical at 10V VGS
- MOSFET  $Q_g(\text{total})$  is 110nC max

TI recommends to make sure that the short-circuit conditions such  $V_{BATT\_MAX}$  and  $I_{SC}$  are within SOA of selected FETs (Q1 and Q2) for  $>t_{SC}$  (5 $\mu$ s max) timing.

### **Selection of Bootstrap Capacitor, $C_{BST}$**

The internal charge pump charges the external bootstrap capacitor (connected between BST and SRC pins) with approximately 600 $\mu$ A. Use the following equation to calculate the minimum required value of the bootstrap capacitor for driving two parallel BUK7J1R4-40H MOSFETs.

$$C_{BST} = \frac{Q_{g(\text{total})}}{1V} \quad (24)$$

Choose closest available standard value: 220nF, 10 %.

### **Programming the $I^2t$ Profile, $R_{IOC}$ and $C_{I2t}$ Selection**

The  $R_{IOC}$  sets the  $I^2t$  protection start threshold, whose value can be calculated using following equation:

$$R_{IOC} \left( \Omega \right) = \frac{V_{(REF\_OC)}}{K \times (I_{OC})^2} \quad (25)$$

where scaling factor, K can be calculate based on following equation:

$$\text{Scaling factor} \left( K \right) = \frac{\left( 0.1 \times \frac{R_{SNS}}{R_{SET}} \right)^2}{I_{BIAS}} \quad (26)$$

To set 40A as  $I^2t$  protection start threshold,  $R_{IOC}$  value is calculated to be 23k $\Omega$ .

Choose the closest available standard value: 23k $\Omega$ , 1%.

The time to turn OFF the gate drive at maximum overcurrent limit ( $I_{OC\_MAX}$ ) can be determined using below equation:

$$t_{OC\_MIN} \left( s \right) = \frac{I^2t \text{ factor}}{I_{OC\_MAX} \times I_{OC\_MAX}} \quad (27)$$

To set 3000A<sup>2</sup>s as  $I^2t$  factor,  $t_{OC\_MIN}$  value is calculated to be 208ms.

Use Equation 28 to calculate the required  $C_{I2t}$  value:

$$C_{I2t} \left( F \right) = \frac{K \times t_{OC\_MIN}}{V_{(I2t\_OC)} - V_{(I2t\_OFFSET)}} \times \left[ I_{OC\_MAX}^2 - I_{OC}^2 \right] \quad (28)$$

To set  $3000A^2s$  as  $I^2t$  factor with 40A as  $I^2T$  start threshold and 120A as maximum overcurrent,  $C_{I2t}$  is calculated to be  $\sim 880nF$ .

Choose the closest available standard value: 1 $\mu F$ , 10%.

### **Programming the Short-Circuit Protection Threshold, $R_{ISCP}$ Selection**

The  $R_{ISCP}$  sets the short-circuit protection threshold, whose value can be calculated using following equation:

$$R_{ISCP} (k\Omega) = \frac{I_{SC} \times R_{SNS} - 1.8}{I_{SCP}} \quad (29)$$

To set 130A as short-circuit protection threshold,  $R_{ISCP}$  value is calculated to be 2.53k $\Omega$  for two FETs in parallel. Choose the closest available standard value: 2.55k $\Omega$ , 1%.

### **Programming the Fault Timer Period, $C_{TMR}$ Selection**

For the design example under discussion, the auto-retry time,  $t_{RETRY}$  can be set by selecting appropriate capacitor  $C_{TMR}$  from TMR pin to ground. The value of  $C_{TMR}$  to set 1ms for  $t_{RETRY}$  can be calculated using following equation:

$$t_{RETRY} (s) = 64 \times C_{TMR} \times \left[ \frac{V(TMR\_HIGH) - V(TMR\_LOW)}{I(TMR\_SRC)} \right] \quad (30)$$

To set 1000ms as auto-retry time,  $C_{TMR}$  value is calculated to be 39.06nF.

Choose closest available standard value: 47nF, 10%.

### **Programming the Load Wakeup Threshold, $R_{BYPASS}$ and Q3 Selection**

During normal operation, the resistor  $R_{BYPASS}$  along with bypass FET  $R_{DS(ON)}$  is used to set load wakeup current threshold. For selecting the MOSFET Q3, important electrical parameters are the maximum continuous drain current  $I_D$ , the maximum drain-to-source voltage  $V_{DS(MAX)}$ , the maximum drain-to-source voltage  $V_{GS(MAX)}$ , and the drain-to-source ON resistance  $R_{DS(ON)}$ .

Based on the design requirements, SQS182ELNW-T1 is selected and its ratings are:

- 80V  $V_{DS(MAX)}$  and  $\pm 20V$   $V_{GS(MAX)}$
- $R_{DS(ON)}$  is 11m $\Omega$  typical at 10V  $V_{GS}$
- MOSFET  $Q_{g(total)}$  is 26nC typical
- MOSFET  $V_{GS(th)}$  is 1.4V min
- MOSFET  $C_{ISS}$  is 1457pF typical

$R_{BYPASS}$  resistor value can be selected using below equation:

$$R_{BYPASS} = \frac{V(LWU)}{I_{LWU}} \quad (31)$$

To set 200mA load wakeup current,  $R_{BYPASS}$  resistor is calculated to be 1 $\Omega$ .

The average power rating of the bypass resistor can be calculated by following equation:

$$P_{AVG} = I_{LWU}^2 \times R_{BYPASS} \quad (32)$$

The average power dissipation of  $R_{BYPASS}$  is calculated to be 0.04W.

The peak power dissipation in the bypass resistor is given by following equation:

$$P_{PEAK} = \frac{V_{BATT\_MAX}^2}{R_{BYPASS}} \quad (33)$$

The peak power dissipation of  $R_{BYPASS}$  is calculated to be ~3600W. The peak power dissipation time for power-up with short into LPM can be derived from  $t_{(LPM\_SC)}$  parameter (5 $\mu$ s) in electrical characteristics table.

Based on  $P_{PEAK}$  and  $t_{(LPM\_SC)}$ , Two of 2 $\Omega$ , 1%, 1.5W CRCW25122R00JNEGHP resistor are used in parallel to support both average and peak power dissipation for  $>t_{(LPM\_SC)}$  time. TI suggests the designer to share the entire power dissipation profile of bypass resistor with the resistor manufacturer and get their recommendation.

The peak short-circuit current in bypass path can be calculated based on following equation:

$$I_{PEAK\_BYPASS} = \frac{V_{BATT\_MAX}}{R_{BYPASS}} \quad (34)$$

$I_{PEAK\_BYPASS}$  is calculated to be 60A based on  $R_{BYPASS}$  selected in Equation 31. TI suggest the designer to ensure that operating point ( $V_{BATT\_MAX}$ ,  $I_{PEAK\_BYPASS}$ ) for bypass path (Q3) is within the SOA curve for  $>t_{(LPM\_SC)}$  time.

### Setting the Undervoltage Lockout Set Point, R3 and R4

The undervoltage lockout (UVLO) can be adjusted using an external voltage divider network of R3 and R4 connected between VS, EN/UVLO and GND pins of the device. The values required for setting the undervoltage and overvoltage are calculated by solving below equation:

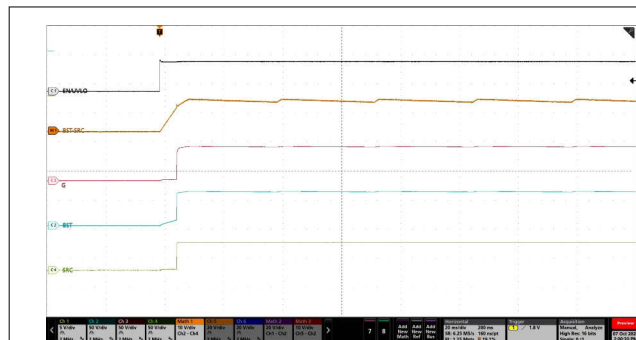
$$V_{(UVLOR)} = V_{INUVLO} \times \frac{R4}{R3 + R4} \quad (35)$$

For minimizing the input current drawn from the power supply, TI recommends to use higher values of resistance for R3 and R4. However, leakage currents due to external active components connected to the resistor string can add error to these calculations. So, the resistor string current,  $I_{(R34)}$  must be chosen to be 20 times greater than the leakage current of UVLO pin.

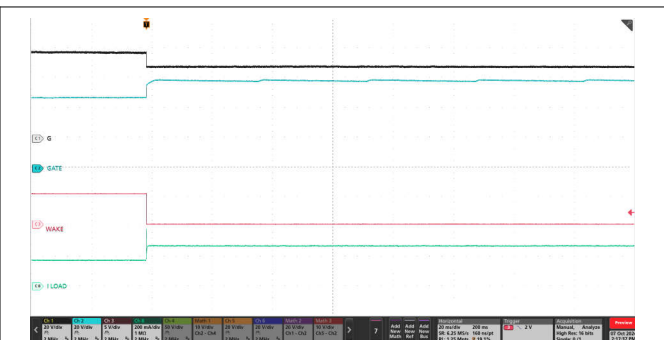
From the device electrical specifications,  $V_{(UVLOR)} = 1.2V$ . From the design requirements,  $V_{INUVLO}$  is 24V. To solve the equation, first choose the value of  $R3 = 470k\Omega$  and use Equation 35 to solve for  $R4 = 24.3k\Omega$ .

Choose the closest standard 1% resistor values:  $R3 = 470k\Omega$ , and  $R4 = 24.9k\Omega$ .

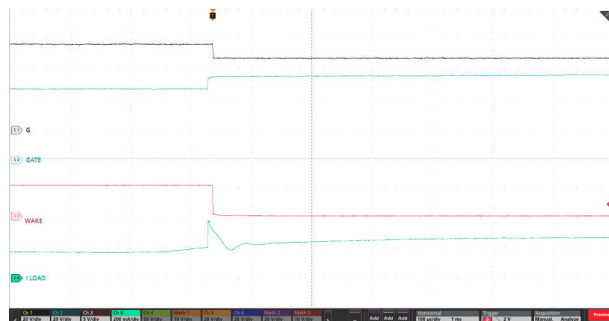
### 9.2.3 Application Curves



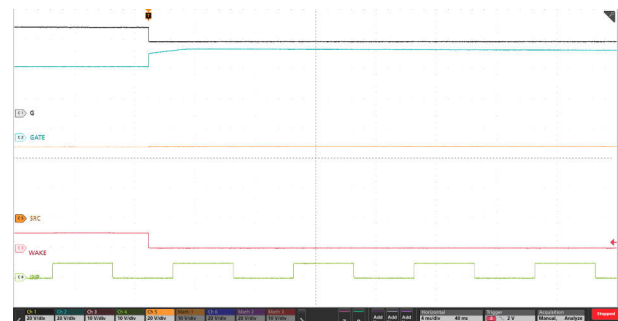
**Figure 9-2. Start-Up Profile of Low Power Path**  
( $LPM = Low$ ,  $VIN = 48V$ , No Load,  $C_{BST} = 470nF$ )



**Figure 9-3. State Transition From LPM to Active Mode**  
( $LPM = Low$ ,  $VIN = 48V$ ,  $EN/UVLO = High$ )



**Figure 9-4. Zoom-In View of State Transition From LPM to Active Mode ( $\overline{\text{LPM}}$  = Low,  $V_{\text{IN}}$  = 48V,  $\text{EN}/\text{UVLO}$  = High)**



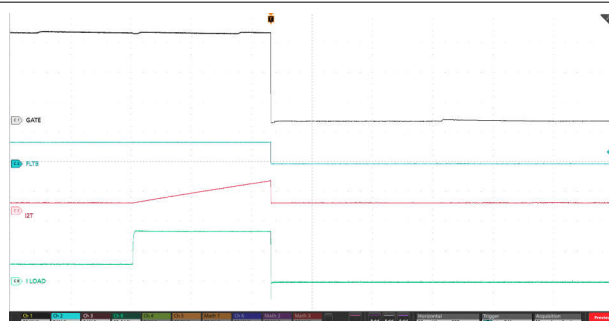
**Figure 9-5. When  $\overline{\text{LPM}}$  = Low in LOAD WAKEUP state,  $\text{INP}$  Has No Control on GATE**



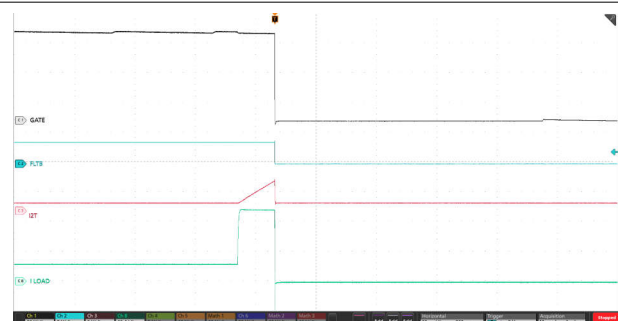
**Figure 9-6. State Transition From LPM to Active Mode ( $\overline{\text{LPM}}$  = Low to High,  $V_{\text{IN}}$  = 48V, No Load)**



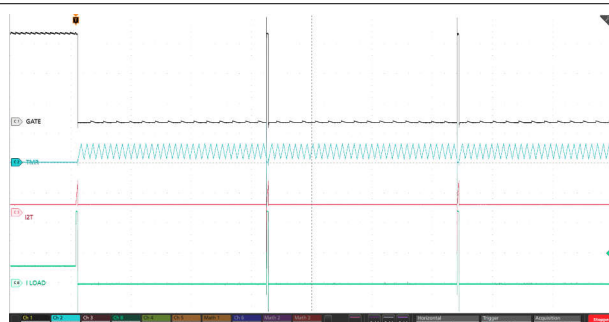
**Figure 9-7. With  $\overline{\text{LPM}}$  = Low to High,  $\text{INP}$  Gained Control on GATE ( $V_{\text{IN}}$  = 48V, No Load)**



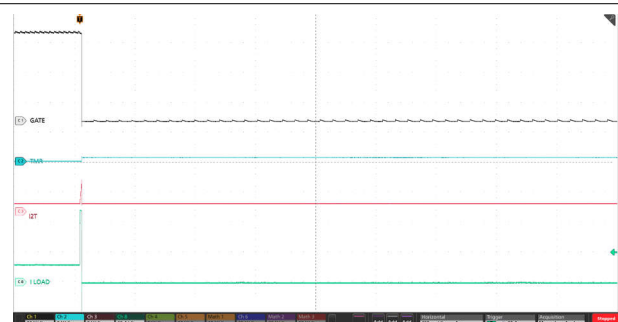
**Figure 9-8.  $\text{I}^2\text{T}$  based Overcurrent Response of TPS4812-Q1 EVM for 6A to 16A Load Step**



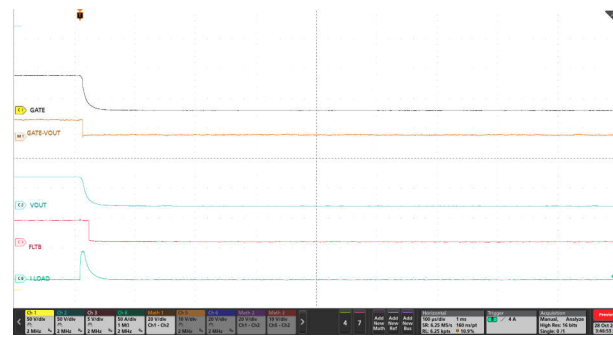
**Figure 9-9.  $\text{I}^2\text{T}$  based Overcurrent Response of TPS4812-Q1 EVM for 6A to 23A Load Step**



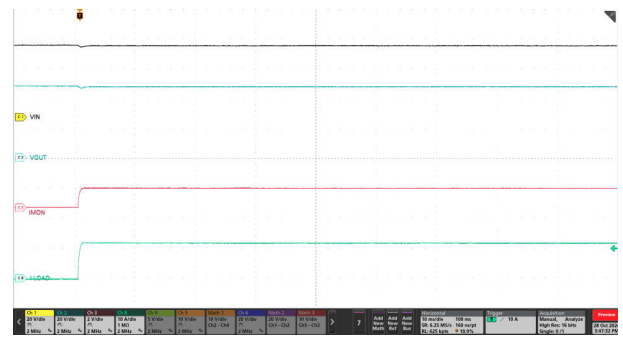
**Figure 9-10. Auto-Retry Response of TPS4812-Q1 for an  $\text{I}^2\text{T}$ -Based Overcurrent Fault**



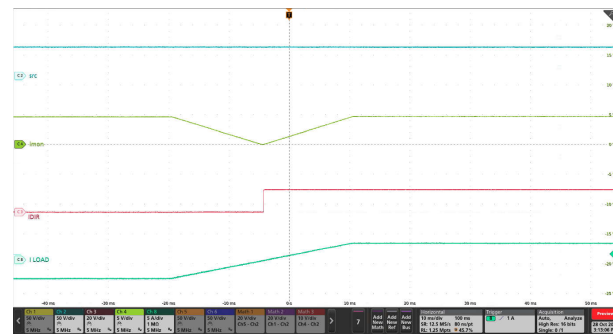
**Figure 9-11. Latch-Off Response of TPS4812-Q1 for an  $\text{I}^2\text{T}$ -Based Overcurrent Fault**



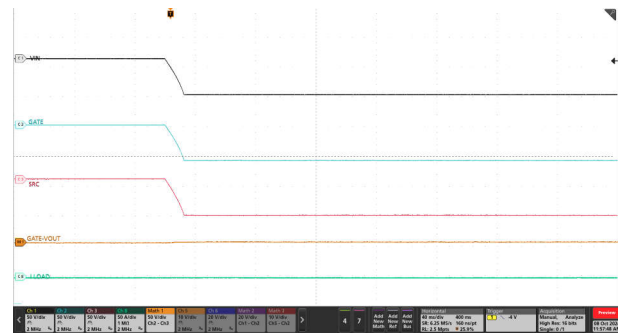
**Figure 9-12. Output Short-Circuit Response of TPS4812-Q1**



**Figure 9-13. TPS4812-Q1 Current Monitoring Output (IMON) Transient Response**

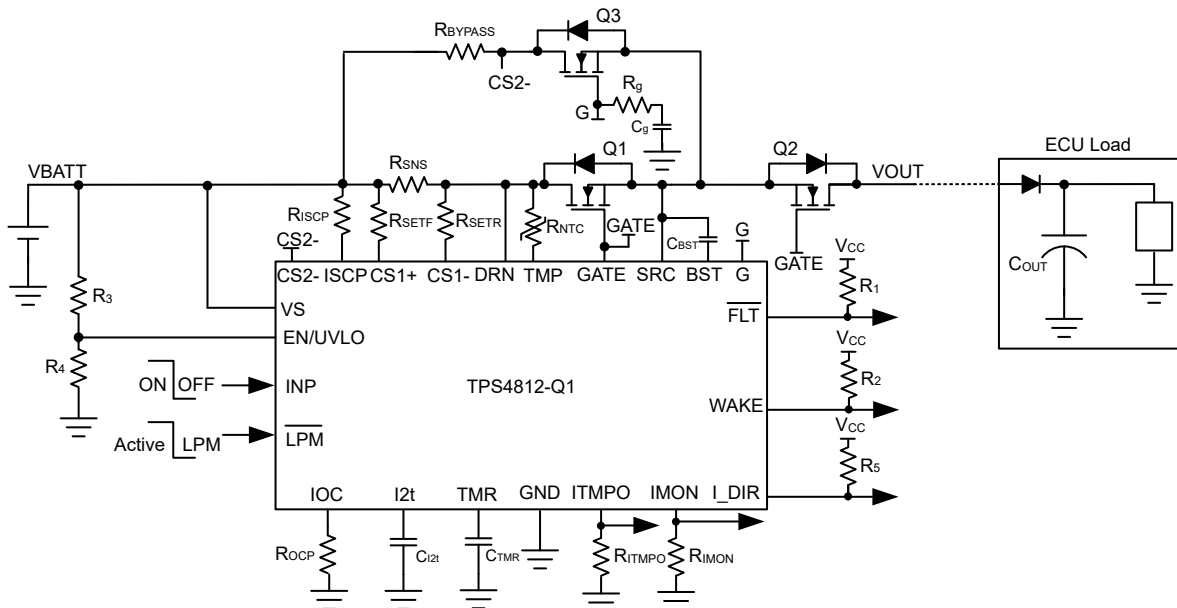


**Figure 9-14. TPS4812-Q1 Bi-directional Current Monitoring Output (IMON, I\_DIR) Transient Response**



**Figure 9-15. GATE Turn-OFF During Input Reverse Battery Fault**

### 9.3 Typical Application 2: Driving Power at all times (PAAT) Loads With Automatic Load Wakeup and Output Bulk Capacitor Charging



**Figure 9-16. TPS4812-Q1 Application circuit for driving power at all times (PAAT) loads with automatic load wakeup and output bulk capacitor charging**

### 9.3.1 Design Requirements

**Table 9-2. Design Parameters**

| PARAMETER                                                 | VALUE                |
|-----------------------------------------------------------|----------------------|
| Typical input voltage, $V_{BATT\_MIN}$ to $V_{BATT\_MAX}$ | 36V to 60V           |
| Undervoltage lockout set point, $V_{INUVLO}$              | 24V                  |
| Maximum load current, $I_{OUT}$                           | 35A                  |
| $I^2T$ Start threshold, $I_{OC}$                          | 40A                  |
| $I^2T$ Protection threshold                               | 3000A <sup>2</sup> s |
| Maximum overcurrent threshold, $I_{OC\_MAX}$              | 120A                 |
| Short-circuit protection threshold, $I_{SC}$              | 130A                 |
| Fault response                                            | Auto-retry           |
| Auto-retry time                                           | 1000ms               |
| Load wakeup threshold, $I_{LWU}$                          | 200mA                |
| Output bulk capacitor, $C_{OUT}$                          | 1mF                  |
| $C_{OUT}$ charging time, $T_{charge}$                     | 40ms                 |

### 9.3.2 External Component Selection

By following similar design procedure as outlined in , the external component values are calculated as below:

- $R_{SNS} = 0.5m\Omega$
- $R_{SET} = 300\Omega$
- $R_{IMON} = 18.2k\Omega$
- $R_{IOC} = 23k\Omega$  to set 40A as  $I^2t$  protection start threshold
- $C_{I2t} = 1\mu F$  to set 3000A<sup>2</sup>s as  $I^2T$  factor
- $C_{BST} = 220nF$
- $R_{ISCP} = 2.55k\Omega$  to set 130A as short-circuit protection threshold
- $C_{TMR} = 47nF$  to set 1000ms auto-retry time
- R3 and R4 are selected as 470k $\Omega$  and 24.9k $\Omega$  respectively to set VIN undervoltage lockout threshold at 24V

#### Programming the Load Wakeup Threshold, $R_{BYPASS}$ and Q3 Selection

During normal operation, the series resistor  $R_{BYPASS}$  is used to set load wakeup current threshold. After  $V_{G\_GOOD}$  threshold is reached, the voltage between DRN and CS2– is compared against  $V_{(LWU)}$  threshold (200mV typ) for load wakeup event. For selecting the MOSFET Q3, important electrical parameters are the maximum continuous drain current  $I_D$ , the maximum drain-to-source voltage  $V_{DS(MAX)}$ , the maximum drain-to-source voltage  $V_{GS(MAX)}$ , and the drain-to-source ON resistance  $R_{DS(ON)}$ .

Based on the design requirements, IAUS200N08S5N023 is selected and its ratings are:

- 80V  $V_{DS(MAX)}$  and  $\pm 20V$   $V_{GS(MAX)}$
- $R_{DS(ON)}$  is 2.3m $\Omega$  typical at 10V VGS

$R_{BYPASS}$  resistor value can be selected using below equation:

$$R_{BYPASS} = \frac{V_{(LWU)}}{I_{LWU}} \quad (36)$$

To set 200mA load wakeup current,  $R_{BYPASS}$  resistor is calculated to be 1 $\Omega$ .

The average power rating of the bypass resistor can be calculated by following equation:

$$P_{AVG} = I_{LWU}^2 \times R_{BYPASS} \quad (37)$$

The average power dissipation of  $R_{BYPASS}$  is calculated to be 0.04W.

The peak power dissipation in the bypass resistor is given by following equation:

$$P_{PEAK} = \frac{V_{BATT\_MAX}^2}{R_{BYPASS}} \quad (38)$$

The peak power dissipation of  $R_{BYPASS}$  is calculated to be ~3600W. The peak power dissipation time for power-up with short into LPM can be derived from  $t_{(LPM\_SC)}$  parameter (5μs) in electrical characteristics table.

Based on  $P_{PEAK}$  and  $t_{(LPM\_SC)}$ , Two of 2Ω, 1%, 1.5W CRCW25122R00JNEGHP resistor are used in parallel to support both average and peak power dissipation for  $> t_{(LPM\_SC)}$  time. TI suggests the designer to share the entire power dissipation profile of bypass resistor with the resistor manufacturer and get their recommendation.

The peak short-circuit current in bypass path can be calculated based on following equation:

$$I_{PEAK\_BYPASS} = \frac{V_{BATT\_MAX}}{R_{BYPASS}} \quad (39)$$

$I_{PEAK\_BYPASS}$  is calculated to be 60A based on  $R_{BYPASS}$  selected in [Equation 36](#). TI suggest the designer to ensure that operating point ( $V_{BATT\_MAX}$ ,  $I_{PEAK\_BYPASS}$ ) for bypass path (Q3) is within the SOA curve for  $> t_{(LPM\_SC)}$  time.

### **Programming the Inrush Current, $R_g$ and $C_g$ Selection**

Use following equation to calculate the  $I_{INRUSH}$ :

$$I_{INRUSH} = C_{LOAD} \times \frac{V_{BATT\_MAX}}{T_{charge}} \quad (40)$$

$I_{INRUSH}$  calculated in [Equation 40](#) should be always less than wakeup in short in low power mode ( $I_{LPM\_SC}$ ) current which can be calculated using following equation:

$$I_{LPM\_SC} = \frac{2V}{R_{BYPASS}} \quad (41)$$

For 1Ω  $R_{BYPASS}$ ,  $I_{LPM\_SC}$  is calculated to be 2A which is less than  $I_{INRUSH}$ .

Use following equation to calculate the required  $C_g$  based on  $I_{INRUSH}$  calculated in [Equation 40](#).

$$C_g = \frac{C_{LOAD} \times I_{(G)}}{I_{INRUSH}} \quad (42)$$

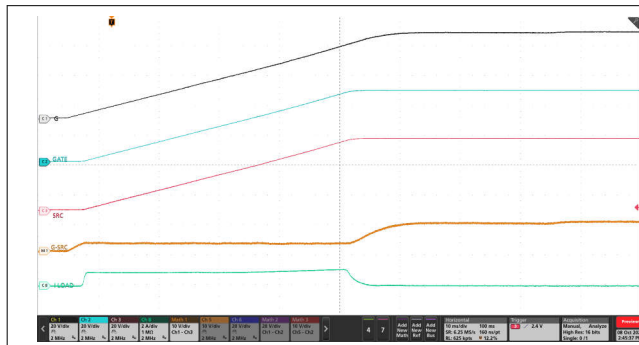
Where,  $I_{(G)}$  is 100μA (typical)

To set  $I_{INRUSH}$  at 1.5A,  $C_g$  value is calculated to be ~50nF.

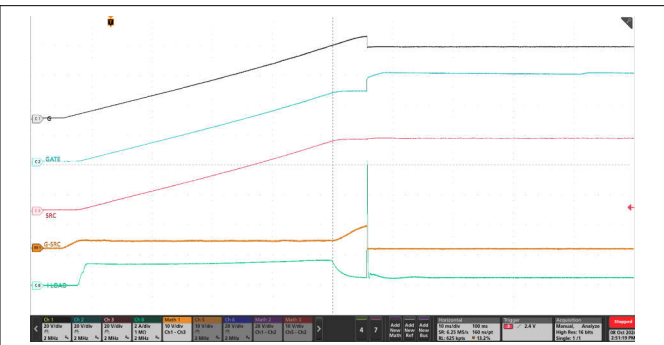
A series resistor  $R_g$  must be used in conjunction with  $C_g$  to limit the discharge current from  $C_g$  during turn-off .

The chosen value of  $R_g$  is 100Ω and  $C_g$  is 68nF.

### 9.3.3 Application Curves



**Figure 9-17. Inrush Current Profile With 1000µF at the Output ( $\overline{\text{LPM}}$  = Low)**



**Figure 9-18. Inrush Current Profile With 1000µF at the Output and 0.5A Load ( $\overline{\text{LPM}}$  = Low)**

## 9.4 Power Supply Recommendations

When the external MOSFETs turn-OFF during the conditions such as INP control, overcurrent or short-circuit protection causing an interruption of the current flow, the input parasitic line inductance generates a positive voltage spike on the input and output parasitic inductance generates a negative voltage spike on the output. The peak amplitude of voltage spikes (transients) depends on the value of inductance in series to the input or output of the device. These transients can exceed the Absolute Maximum Ratings of the device if steps are not taken to address the issue. Typical methods for addressing transients include:

- Use of a TVS diode and input capacitor filter combination across input to and GND to absorb the energy and dampen the positive transients.
- Use of a diode or a TVS diode across the output and GND to absorb negative spikes.

The TPS4812-Q1 gets powered from the VS pin. Voltage at this pin must be maintained above  $V_{(\text{VS\_PORR})}$  level to ensure proper operation. If the input power supply source is noisy with transients, then TI recommends to place a  $R_{\text{VS}} - C_{\text{VS}}$  filter between the input supply line and VS pin to filter out the supply noise. TI recommends an  $R_{\text{VS}}$  value around 100-Ω and  $C_{\text{VS}}$  value around 0.1 µF.

TPS4812-Q1 uses DRN pin for sensing input reverse polarity fault event. If the input power supply source is noisy with transients, then TI recommends to place a  $R_{\text{DRN}} - C_{\text{DRN}}$  filter between the input supply line and DRN pin to filter out the supply noise. TI recommends an  $R_{\text{DRN}}$  value around 10-Ω and  $C_{\text{DRN}}$  value around 0.1 µF.

In a case where large  $di/dt$  is involved, the system and layout parasitic inductances can generate large differential signal voltages between CS1+ and CS1- pins. This action can trigger false short-circuit protection and nuisance trips in the system. To overcome such scenario, TI suggests to add a placeholder for RC filter components across the sense resistor ( $R_{\text{SNS}}$ ) and tweak the values during test in the real system.

Figure 9-19 shows the circuit implementation with optional protection components.

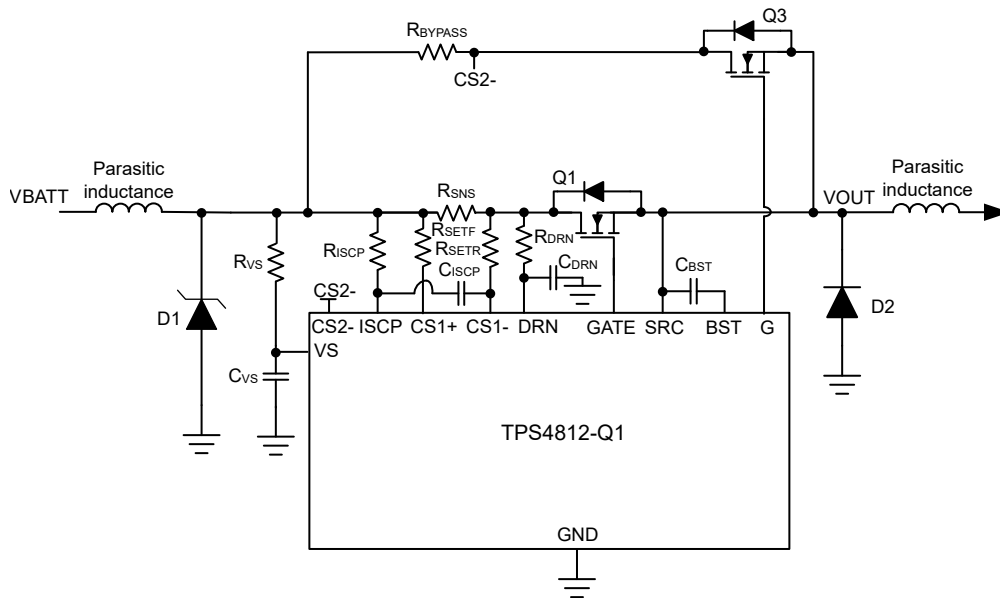


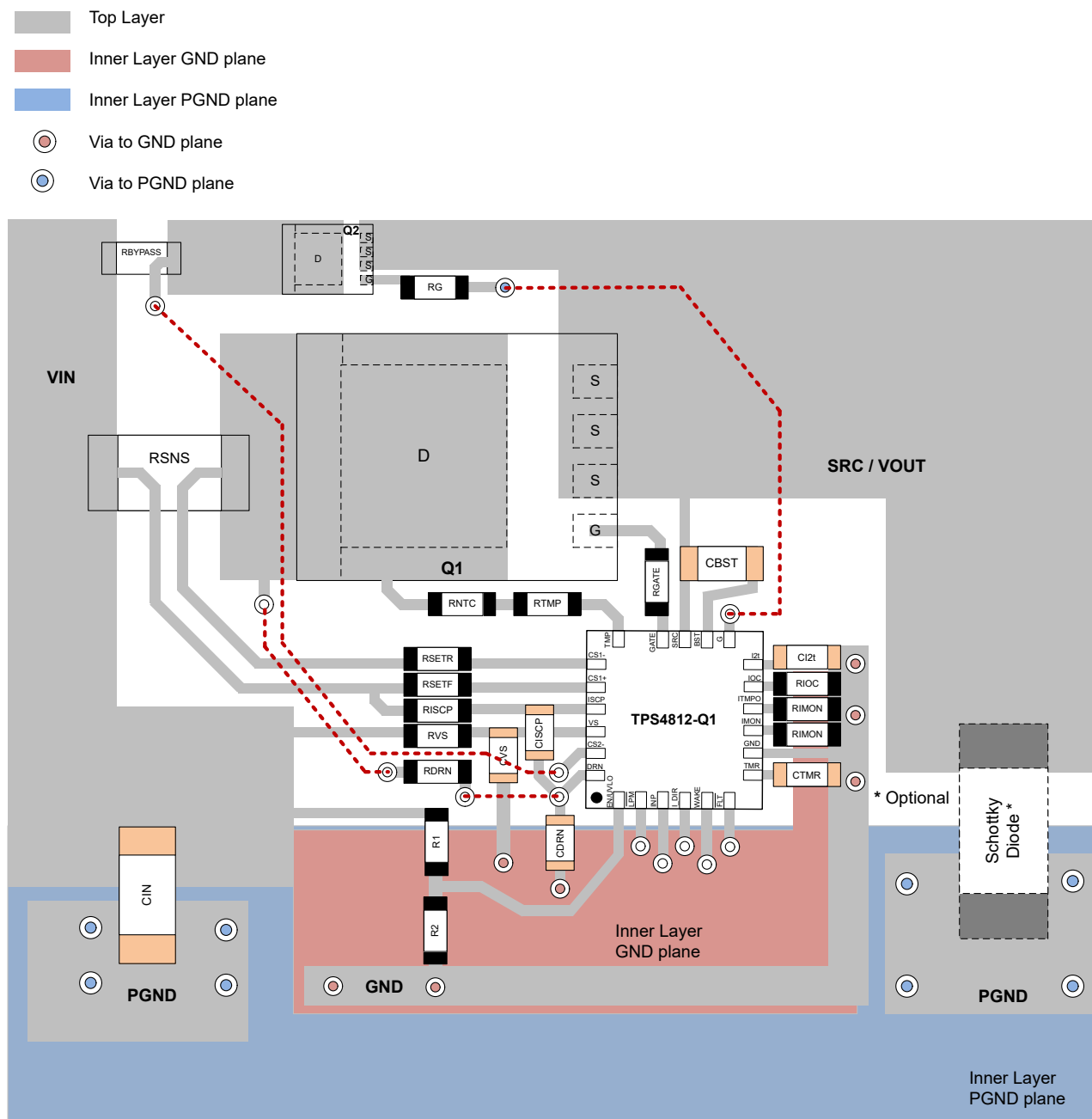
Figure 9-19. Circuit Implementation With Optional Protection Components For TPS4812-Q1

## 9.5 Layout

### 9.5.1 Layout Guidelines

- The sense resistor ( $R_{SNS}$ ) must be placed close to the TPS4812-Q1 and then connect  $R_{SNS}$  using the Kelvin techniques. Refer to [Choosing the Right Sense Resistor Layout](#) for more information on the Kelvin techniques.
- For all the applications, TI recommends a 0.1  $\mu$ F or higher value ceramic decoupling capacitor between VS terminal and GND. Consider adding RC network at the supply pin (VS) of the controller to improve decoupling against the power line disturbances.
- The high current path from the board's input to the load, and the return path, must be parallel and close to each other to minimize loop inductance.
- The external MOSFETs must be placed close to the controller such that the GATE of the MOSFETs are close to GATE pin to form short GATE loop. Consider adding a place holder for a resistor in series with the Gate of each external MOSFET to damp high frequency oscillations if need arises.
- Place a TVS diode at the input to clamp the voltage transients during hot-plug and fast turn-off events.
- The external boot-strap capacitor must be placed close to BST and SRC pins to form very short loop.
- The ground connections for the various components around the TPS4812-Q1 must be connected directly to each other, and to the TPS4812-Q1's GND, and then connected to the system ground at one point. Do not connect the various component grounds to each other through the high current ground line.

### 9.5.2 Layout Example



**Figure 9-20. Typical PCB Layout Example of TPS4812-Q1**

## 10 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

### 10.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](https://www.ti.com). Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 10.2 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

### 10.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.  
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### 10.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 10.5 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

## 11 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| DATE          | REVISION | NOTES           |
|---------------|----------|-----------------|
| December 2024 | *        | Initial Release |

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable part number           | Status<br>(1) | Material type<br>(2) | Package   Pins  | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|---------------------------------|---------------|----------------------|-----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">TPS48120QRGERQ1</a> | Active        | Production           | VQFN (RGE)   23 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | TPS<br>48120Q       |
| TPS48120QRGERQ1.A               | Active        | Production           | VQFN (RGE)   23 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | TPS<br>48120Q       |
| <a href="#">TPS48121QRGERQ1</a> | Active        | Production           | VQFN (RGE)   23 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | TPS<br>48121Q       |
| TPS48121QRGERQ1.A               | Active        | Production           | VQFN (RGE)   23 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | TPS<br>48121Q       |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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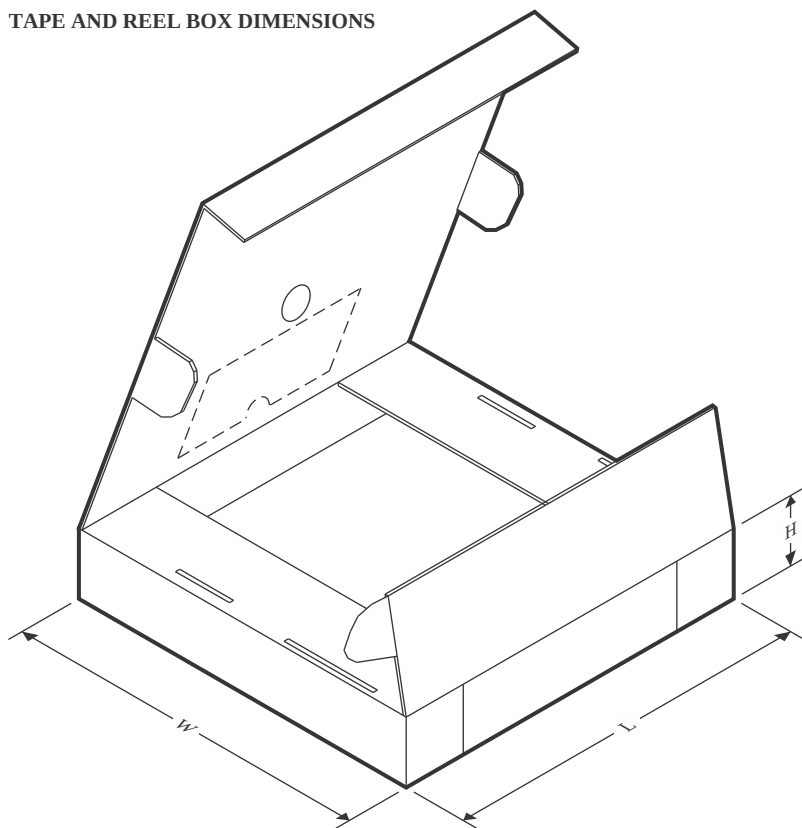
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

| Device          | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-----------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| TPS48120QRGERQ1 | VQFN         | RGE             | 23   | 3000 | 330.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| TPS48121QRGERQ1 | VQFN         | RGE             | 23   | 3000 | 330.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device          | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-----------------|--------------|-----------------|------|------|-------------|------------|-------------|
| TPS48120QRGERQ1 | VQFN         | RGE             | 23   | 3000 | 360.0       | 360.0      | 36.0        |
| TPS48121QRGERQ1 | VQFN         | RGE             | 23   | 3000 | 360.0       | 360.0      | 36.0        |

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